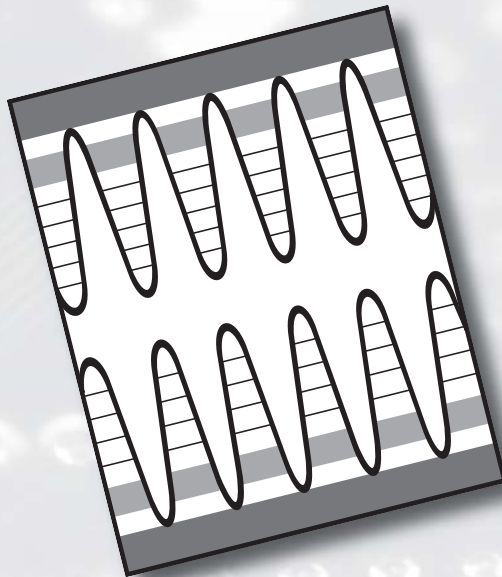


*The Premier Conference for
Advances in Electronic Materials*

**47th ANNUAL TMS
ELECTRONIC MATERIALS
CONFERENCE
AND EXHIBIT**

University of California, Santa Barbara
June 22-24, 2005



ADVANCE PROGRAM

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TMS

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www.tms.org/EMC.html

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To begin enjoying these benefits, complete the enclosed membership application and return it to TMS' registration desk during the conference with the \$52.50 membership fee. You may also join online at www.tms.org/Society/membership.html, or mail your application to TMS, 184 Thorn Hill Road, Warrendale, PA 15086, USA. For more information, visit www.tms.org, e-mail membership@tms.org, or call (724) 776-9000, ext 259.

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<http://www.tms.org>

TMS

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EMC registration and campus housing forms are at the back of this brochure. Early registration and housing reservations are advised.

GENERAL INFORMATION

INTENDED AUDIENCE

The Electronic Materials Conference (EMC) covers significant topics in the areas of preparation and characterization of electronic materials. Individuals actively engaged or interested in electronic materials research and development find this conference invaluable. With an international audience of 20 percent, each year more than 500 students, professors, scientists, engineers, researchers, technicians, R&D managers, and product managers attend.

DATE AND LOCATION

EMC is being held at the University of California, Santa Barbara, California, June 22-24, 2005. This conference is being coordinated with the Device Research Conference (DRC) sponsored by IEEE, which takes place June 20-22 at the same location.

CONFERENCE REGISTRATION

Advance registration is encouraged to avoid delays with check-in at the conference. Both EMC and DRC badges are accepted by both conferences on Wednesday, June 22. *EMC advance registration fees:* full conference \$385; one day \$325; student \$150.

EMC registration fee includes welcoming reception, coffee breaks, Thursday banquet, all technical sessions and exhibition. One-day fee does not include the Thursday banquet.

Register in advance at www.tms.org/EMC.html or complete the registration form provided in the center of this mailer. *Advance registrations are accepted until June 1, 2005.* For questions concerning registration, telephone TMS Meeting Services at (724) 776-9000, ext. 243; fax (724) 776-3770; or e-mail mtgserv@tms.org.

On-site registration is at an increased rate. On-site registration and advance registrant badge pick-up are located in the Multicultural Lounge during the following hours:

Tuesday, June 21.....3 to 5 p.m.
Wednesday, June 22 7:30 a.m. to 5 p.m.
Thursday, June 23..... 7:30 a.m. to 4 p.m.
Friday, June 24..... 7:30 to 10 a.m.

REFUND POLICY

A written request must be sent to TMS, 184 Thorn Hill Road, Warrendale, PA 15086, USA, postmarked no later than June 1s, 2005. A \$75 processing fee is charged on all cancellations. NO refunds are issued after the deadline date.

TECHNICAL SESSIONS

The technical program commences at 8:30 a.m. on Wednesday, June 22. All sessions are held on grounds at the University of California. University Center/Corwin Pavilion is the location of the conference plenary session. Session and paper titles are included in this brochure.

For technical program information regarding EMC, contact:

April S. Brown, EMC General Chair
Telephone (919) 660-5498
Fax (919) 660-5293
E-mail abrown@ee.duke.edu

Or

Edward Yu, EMC Program Chair
Telephone (858) 534-6619
Fax (858) 822-3425
E-mail ety@ece.ucsd.edu

LATE NEWS PAPERS

Late news papers are considered. Authors must submit their abstracts by June 3, 2005, online at <http://cmsplus.tms.org>. Click on 2005 Electronic Materials Conference. Authors of accepted papers are notified before the conference.

COMPUTER/NETWORK FACILITIES

Registrants have Internet access through UCSB's ResNet Ethernet network in the residence halls only. A temporary username and password is provided to on-campus registrants upon check-in.

DRESS

Casual clothing is in order with a sweater or light jacket occasionally needed for the evenings. The university is essentially a pedestrian campus, so be sure to wear comfortable walking shoes.

STUDENT TRAVEL ASSISTANCE

Student authors who plan to present papers at EMC may be eligible for travel assistance. To apply for assistance, submit an application no later than June 1, 2005 to:

April S. Brown, EMC General Chair
Duke University
130 Hudson Hall
Durham, NC 27708
Telephone (919) 660-5498
Fax (919) 660-5293
E-mail abrown@ee.duke.edu

Student travel assistance is made possible through generous donations from the Electronic, Magnetic, & Photonic Materials Division (EMPMD) of TMS and the EMC Foundation.

AMERICANS WITH DISABILITIES ACT



TMS strongly supports the federal Americans with Disabilities Act (ADA), which prohibits discrimination against and promotes public accessibility for those with disabilities. In support of and in compliance with ADA, we ask those attendees of EMC requiring specific equipment or services to indicate their needs on the enclosed housing form or to contact TMS Meeting Services.

POLICY ON AUDIO AND VIDEO RECORDING OF PRESENTATIONS/SESSIONS

TMS reserves the right to any audio and video reproduction of all presentations at every TMS sponsored meeting. Recording of sessions (audio, video, still photography, etc.) intended for personal use, distribution, publication, or copyright without the express written consent of TMS and the individual authors is strictly prohibited. Contact TMS Technical Programming to obtain a copy of the waiver release form.

FOR MORE INFORMATION

Regarding conference logistics, contact:

Michael Packard, CMP
Manager, TMS Meeting Services
Telephone (724) 776-9000, ext. 225
Fax (724) 776-3770
E-mail packard@tms.org

Regarding meeting registration and pricing, contact:

TMS Meeting Services
Telephone (724) 776-9000, ext. 243
Fax (724) 776-3770
E-mail mtgserv@tms.org

Pertaining to the Device Research Conference (DRC), contact:

Alan Seabaugh, DRC General Program Chair
Telephone (574) 631-4473
Fax (574) 631-4393
E-mail seabaugh.1@nd.edu

Or

Theresa Mayer, DRC Technical Program Chair
Telephone (814) 863-8458
Fax (814) 863-8341
E-mail tsm2@psu.edu

EXHIBITION & SPONSORSHIP

EMC is hosting a unique showcase for suppliers of technology related to the preparation and characterization of electronic materials. Exhibitors are invited to display equipment, instrumentation, products, software, publications and services relating to electronic materials science, industry and research.

EXHIBITOR PRODUCTS AND SERVICES AT A GLANCE

- Advanced Thin-film Characterization
- Chemical Vapor Deposition (CVD)
- Compound Semiconductor Materials
- Failure Analysis
- GaAs and InP Based Epitaxial Wafers; Substrates
- High Performance Purification
- High Purity Metalorganics
- III-V Materials
- Materials Characterization
- MOCVD
- Optoelectronics
- Sapphire Substrates
- Scanning Probe and Electron Microscopes
- Silicon Heterostructures
- Ultra High Purity (UHP) Metals, Gas and Chemical
- Wafer Processing Equipment
- Wide Bandgap Semiconductors

EXHIBIT DATES AND HOURS

Wednesday, June 229:20 a.m. to 4 p.m. and 6 to 8 p.m.
Thursday, June 23 10 a.m. to 4 p.m.

EXHIBITION FEE OF \$1200 INCLUDES:

- One (1) eight foot table
- Two (2) chairs
- Standard electrical service
- Complimentary listing in show directory—distributed to all meeting registrants
- One (1) complimentary registration to technical sessions and exhibits
- Hosted welcoming reception in exhibition area
- Hosted coffee and refreshment breaks in exhibition area
- Post-show report of meeting participants
- Exhibition management services

EMC EXHIBITORS TO DATE

- Accent Optical Technologies
- Intrinsic Semiconductor
- IQE
- Johnson Matthey
- k-Space Associates, Inc.
- Kurt J Lesker Co.
- Lake Shore Cryotronics, Inc.
- MMR Technologies Inc.
- Riber
- SAES Pure Gas, Inc.
- Sypris Test and Measurement
- United Minerals & Chemical Corp.
- VBS International, Inc.
- Veeco Instruments
- Wafer Technology Ltd.

EMC 2005 – an unparalleled gathering of industry, science and research professionals in electronic materials. Ensure they learn about your product and services--Reserve your exhibit space today! Complete and return the enclosed exhibition and sponsorship reservation form. Space reservations are accepted on a first-come, first-served basis.

CORPORATE SPONSORSHIP

As the exclusive sponsor of one of EMC's activities, your company name and logo will be prominent to all conference and exhibit attendees via:

- Signage
- TMS Web Site
- Conference Promotional Materials
- Conference Program

Proposed Sponsor Activities

- Welcoming Reception
- Coffee Breaks
- Continental Breakfast
- Conference Social Event/Banquet

To sponsor an EMC activity, or for more information on exhibition and sponsorship opportunities, contact:

Cindy A. Wilson, TMS Exhibits Coordinator
Telephone (724) 776-9000, ext 231
Fax (724) 776-3770
E-mail wilson@tms.org

HOUSING & ACCOMMODATIONS

ON CAMPUS

We are pleased to invite EMC attendees to reside on the seaside campus of UCSB. On-campus accommodations are available on a first request basis; therefore, early registrations and reservations are essential.

UCSB residence halls and dining facilities are located within a 5-10 minute walk from the session meeting rooms and the beach. Residence hall accommodations are either single or double occupancy with single rooms reserved on a first request basis. No rooms have private restrooms; restroom and shower facilities are located on each floor. Lodging includes beds made on arrival day and daily room service with washcloth and towel change. Unfortunately, there is no housing on campus for those with children. We recommend a selection from one of the hotel blocks if you are traveling with children. Check the hotel listings in the off-campus housing section of this brochure.

UCSB offers the following package plans to provide planning flexibility and the option to attend both DRC and EMC. Residence hall package plans C, D, and E include full meal service. Residence hall room packages without meals are not available.

No adjustments from the chosen package for lodging or meals are made for late arrival or early departure.

Please indicate your plan preference on the enclosed reservation form and return it with your payment to:

Pam Allen
Campus Conference Services
University of California
Santa Barbara, CA 93106-6120
Fax (805) 893-7287
E-mail pallen@housing.ucsb.edu

Confirmations are sent by the conference office for reservations received at the university by *May 31, 2005*. Prepayment is required.

METHOD OF PAYMENT

Payment in U.S. dollars may be made by check or money order. Checks must be drawn on a U.S. bank and made payable to "U.C. Regents."

Visa, MasterCard, or American Express credit cards are also accepted.

PLAN C

(for those attending DRC and EMC) Includes lodging Sunday through Thursday night and 13 meals:

Sundaydinner
Monday.....breakfast, lunch, and dinner
Tuesdaybreakfast and lunch (no dining commons meal offered Tuesday night due to DRC banquet)
Wednesday...breakfast, lunch, and dinner
Thursdaybreakfast and lunch (no dining commons meal offered Thursday night due to EMC banquet)
Fridaybreakfast and lunch

Per person \$429.05/single occupancy; \$349.75/double occupancy

PLAN D

Includes lodging Tuesday through Thursday night and eight meals:

Tuesday dinner
Wednesday...breakfast, lunch, and dinner
Thursdaybreakfast and lunch (dinner at Natural History Museum included with EMC registration - no dining commons meal offered)
Fridaybreakfast and lunch

Per person \$267.63/single occupancy; \$220.04/double occupancy

PLAN E

Includes lodging Wednesday through Thursday night and six meals:

Wednesday...lunch and dinner
Thursdaybreakfast and lunch (dinner at Natural History Museum included with EMC registration - no dining commons meal offered)
Fridaybreakfast and lunch

Per person \$192.02/single occupancy; \$160.30/double occupancy

EARLY ARRIVAL

Monday night (June 20) includes Monday dinner, Tuesday breakfast and lunch

Per person \$85.81/single occupancy; \$69.95/double occupancy

LATE DEPARTURE

Friday night (June 24) includes Friday dinner, Saturday breakfast

Per person \$75.61/single occupancy; \$59.75/double occupancy

COMMUTER LUNCH PACKAGE

Attendees who plan to make off-campus housing arrangements directly with the hotel/motel may purchase commuter lunch packages for on-campus meals through UCSB:

Three lunches \$30
Five lunches \$50

It is important to apply early.

ON-CAMPUS DINING HOURS

Meals are served in the De La Guerra Dining Hall:

Breakfast 7 to 8 a.m.
Lunch 11:45 a.m. to 1:15 p.m.
Dinner..... 5:30 to 7 p.m.

Food facilities on campus close at 7 p.m.

No refunds are made for late arrivals, early departures, or missed meals.

OFF-CAMPUS HOUSING

Blocks of rooms have been reserved at special conference rates for the hotels listed below. Rooms may be released as early as May 31. Thereafter, reservations can be obtained only on a space available basis. Make your reservations directly with the hotel via mail, telephone, or fax as soon as possible. Rooms are available for DRC and EMC, Sunday through Thursday nights. You must identify yourself as either a DRC or EMC attendee. Friday or Saturday nights are available if requested at the time a reservation is made. However, the special rates below do not apply to weekend rates. Friday and Saturday rates are higher. The following rates do not include tax.

Hotels in Goleta, approximately five miles from campus (within 10 minutes driving time):

BEST WESTERN SOUTH COAST INN

5620 Calle Real
Goleta, CA 93117

Telephone (805) 967-3200 / Fax (805) 683-4466

\$113 single; \$123 double (Sunday through Thursday night)

All rooms have high speed Internet access, refrigerator, coffeemaker, hairdryer, iron and ironing board. Rate includes daily continental breakfast buffet, evening hospitality Monday through Thursday, and complimentary shuttle service to and from the Santa Barbara Airport.

HOLIDAY INN

5650 Calle Real
Goleta, CA 93117

Telephone (805) 964-6241 / Fax (805) 964-8467

\$139 single/double (Sunday through Thursday night)

Full service restaurant, heated pool, and complimentary airport shuttle between 6 a.m. and 10 p.m.

The following hotel is located off the main entrance of campus (three minutes driving time):

PACIFICA SUITES

5490 Hollister Avenue
Goleta, CA 93117

Telephone (805) 683-6722 / Fax (805) 683-4121

\$169 single/double (Sunday through Thursday night)

Complimentary cooked-to-order breakfast daily, complimentary evening beverages Monday through Saturday, heated pool and spa, and complimentary airport shuttle 7 a.m. to 7 p.m. with 24-hour notice

Hotels in Santa Barbara:

EL ENCANTO HOTEL AND GARDEN VILLAS

1900 Lasuen Road

Santa Barbara, CA 93103

Telephone (805) 687-5000 / Fax (805) 687-0943

\$199 single (Sunday through Thursday night)

Charter Member of Historic Hotels of America

Overlooking the Pacific Ocean, this historic hotel features garden villas and cottages, many with wood-burning fireplaces, private patios or balconies, and dining rooms with outdoor terraces.

RADISSON HOTEL SANTA BARBARA

1111 East Cabrillo Boulevard

Santa Barbara, CA 93103

Telephone (805) 963-0744 / Fax (805) 962-5555

\$129 single/\$139 double (Sunday through Thursday night)

Full American breakfast is included in rate. A Mediterranean style property located across from the East Beach, the hotel has 173 guest rooms plus a swimming pool, fitness center and restaurant. All rooms include a coffeemaker, hairdryer, iron, ironing board and data port modem for online access.

SOCIAL EVENTS

WELCOMING RECEPTION

Attendees are invited to a welcoming reception on Wednesday, June 22 from 6 to 8 p.m. at the University of California in the University Center/Lagoon Plaza.

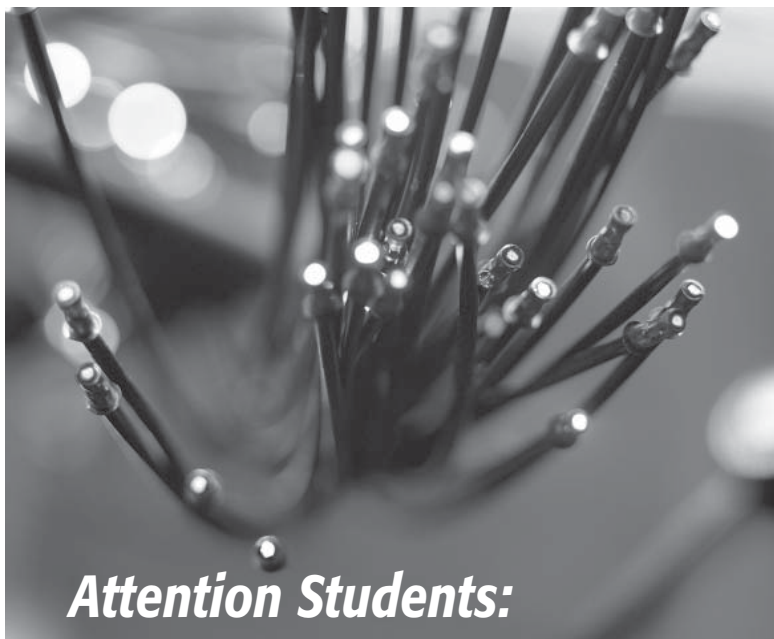
EVENING AT THE NATURAL HISTORY MUSEUM

Conference attendees and their guests may enjoy a catered dinner at the Santa Barbara Natural History Museum on Thursday, June 23. The cost of this event is included in the full conference and student registration fees. It is not included in the one-day registration fee.

One-day registrants and guests may purchase tickets for the Natural History Museum dinner at a cost of \$60 for adults and \$25 for children 12 and under. Tickets may be ordered on the registration form. Advance purchase is encouraged. Tickets are available for purchase at the EMC registration desk until 5 p.m. on Wednesday, June 22.

INFORMAL COFFEE BREAKS

During the intermission of morning and afternoon sessions (approximately 10 to 10:40 a.m. and 3 to 3:40 p.m.) coffee, tea, and sodas are served in the exhibition area (University Center/Lagoon Plaza).



Attention Students:

Join the Material Advantage program for just \$25 and receive membership benefits in three organizations!

- Access to member Web sites and membership directories of the American Ceramics Society, ASM International, and TMS
- A rotating print subscription to the *American Ceramics Society Bulletin*, *Advanced Materials & Processes*, and *JOM*
- Online versions of *American Ceramic Society Bulletin*, *Advanced Materials & Processes*, *JOM* and *TMS Letters*
- Discounted subscription fees to archival journals, such as *Metallurgical and Materials Transactions (A and B)*
- Discounted pricing on books, papers, CDs, software, videos, and more!
- Scholarship and award opportunities totaling more than \$400,000 through societies, chapters and foundations
- Opportunities to compete in society sponsored contests
- Discounted meeting registration fees

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TRANSPORTATION

VEHICLE

UCSB is easily accessible from US 101.

From the south, take UCSB/Highway 217 exit. Bear to the left when entering campus and follow directional signs to the residence halls.

From the north, take US 101 to the Storke/Glen Annie Road exit. Turn right onto Storke Road and proceed two miles to El Colegio Road. Turn left onto El Colegio Road, proceed through the campus West Gate, and follow directional signs to the residence halls.

For those residing off campus, refer to the UCSB campus map for directions to the University Center.

TRAIN

Santa Barbara is served by Amtrak Train Service. The Amtrak terminal is located in downtown Santa Barbara and in Goleta. From the terminal, you may reach campus or the hotel by SuperRide Shuttle or taxi. UCSB campus shuttle cannot provide transportation from the train station for on-campus housing.

AIR

Most people traveling by air land at Los Angeles International Airport (LAX), about two hours from Santa Barbara. From LAX, you may fly to Santa Barbara, take the Santa Barbara Airbus, or rent a car and drive to Santa Barbara.

Flying into Santa Barbara A free UCSB shuttle bus is available for attendees with on-campus housing for transportation from the airport to campus residence halls. To arrange for pick-up, upon landing, attendees must call the telephone number assigned in their confirmation e-mail. Following the conference, the UCSB shuttle bus transports on-campus participants to the airport. Those staying in local hotels are responsible for their own transportation; check the hotel descriptions to determine which hotels provide this service. Alternatives are SuperRide Airport Shuttle, reserve in advance, at (805) 683-9636, Yellow Cab at (805) 965-5111, and Orange Cab at (805) 964-2800.

Santa Barbara Airbus provides several daily bus trips from LAX to Santa Barbara. Within U.S./Canada, phone (800) 423-1618; outside U.S./Canada, (805) 964-7759; or fax (805) 683-0307. For those residing on campus, the Goleta drop-off site must be used. The UCSB shuttle bus transports from Goleta to campus. Attendees must call the number assigned in the confirmation e-mail to secure the shuttle bus. Following the conference, the shuttle bus returns on-campus participants to the Goleta airbus drop-off site. Those staying in hotels are responsible for their transportation from the airbus drop-off site.

Taxi service is available at hotels not offering free shuttle service.

PARKING

Parking is by permit only. On-campus residents receive a complimentary permit at check-in for the duration of their stay.

Off-campus residents are encouraged to purchase permits in advance on the registration form; permits may also be purchased at registration:

EMC Only Parking Permit \$28
DRC/EMC Parking Permit \$37

All attendees must have a temporary parking permit for check-in/registration which can be printed from the following Web site: http://www.housing.ucsb.edu/conferences/web_reg/drc-emc-park.pdf.

Parking citations are issued for cars incorrectly parked or lacking permits. UCSB is a walking campus and parking is limited. Parking assignments may not necessarily be close to assigned residence halls or session locations. Additional parking details are included when confirmations are sent.

CAR RENTAL SPECIAL



Official Car Rental Company of the 47th Annual EMC

Advance reservations may be made by booking online at www.hertz.com or calling the Hertz reservations line at (800) 654-2240 in the U.S. or (800) 263-0600 in Canada. International customers should contact the nearest Hertz reservation center. Advance reservations are recommended.

Travelers must identify themselves as attendees of EMC and reference CV#02QJ0013 in order to receive the special rates.

Rates are available from Hertz locations in Southern California.

Terms and Conditions

- Unlimited mileage allowance on rates
- One-way service fee applies when cars are not returned to renting location.
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- Drivers must meet standard Hertz age, driver, and credit requirements.
- Hertz is a frequent flyer partner with US Airways, Delta, Northwest, United, and American Airlines. Frequent flyer information may be requested at time of car booking.
- Weekly rentals are from five to seven days. Weekend rentals have a minimum two-day keep, and Thursday pick-up requires a minimum three-day keep.

SPECIAL AIRFARE



U·S AIRWAYS

Official Carrier of the 47th Annual EMC

US Airways is pleased to offer the various discount options listed below.

For travel into Santa Barbara, California, attendees receive a five-percent discount off First Class and any published US Airways round trip fare booked in F, C, D, A, Y, B, M or U class of service. A 10% discount on unrestricted "Y" or B8US/B4AUS fares applies with seven-day advance reservations and ticketing required. Plan ahead and receive an additional five-percent discount by ticketing 60 days or more prior to departure. These discounts are valid provided all rules and restrictions are met and are applicable for travel from all points on US Airways' route system. The above discounts are not combinable with other discounts or promotions and are valid three days before and after the meeting dates. Additional restrictions may apply on international travel.

US Airways also offers zone fares for attendees who are unable to meet the restrictions of the discounts listed above. Certain restrictions, including advance purchase requirements, may apply.

These special rates are applicable for travel from the continental United States. To obtain these discounts, travelers or their professional travel consultants must call US Airways' Group and Meeting Reservation Office toll-free at (877) 874-7687; Monday through Friday, 8 a.m. to 8 p.m., Saturday and Sunday, 8 a.m. to 6 p.m., Eastern time.

REFER TO GOLD FILE NO. 57153207

Publications TMS

Enhance your electronic materials library with these proceedings available from related TMS conferences.

CALPHAD AND ALLOY THERMODYNAMICS

Patrice E.A. Turchi, Antonios Gonis, and Robert D. Shull, editors
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S. Ankem, C.S. Pande, I. Ovid'ko, and R. Ranganathan, editors

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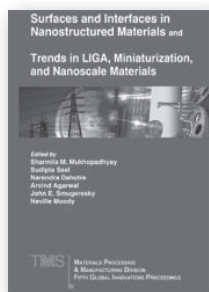
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SURFACES AND INTERFACES IN NANOSTRUCTURED MATERIALS AND TRENDS IN LIGA, MINIATURIZATION, AND NANOSCALE MATERIALS 5th MPMD Global Innovations Symposium

Sharmila M. Mukhopadhyay, John Smugeresky, Sudipta Seal, Narendra B. Dahotre, and Arvind Agarwal, editors

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THE SCIENCE OF COMPLEX ALLOY PHASES

P. Turchi and T. Massalski, editors

324 pp., illus., index, hardcover

Published in honor of 2005 Hume-Rothery Award recipient Uichiro Mizutani. This book emphasizes both theoretical and experimental aspects of electronic, structural, and thermodynamic properties of complex alloy phases. Leading experts provide an assessment of the current understanding of the structural properties of complex materials, including quasicrystalline and amorphous alloys. Special emphasis is placed on the understanding of why nature is able to stabilize complex atomic arrangements and on recent results related to structurally complex alloy phases.

Order No. 05-593X • Weight 2 lbs.
M \$125 ♦ S \$99 ♦ L \$179



THE SELECTED WORKS OF JOHN W. CAHN

W. Craig Carter and William C. Johnson, editors

559 pp., illus., softcover, CD-ROM, or Portable Document Format

This book represents a collection of 30 selected papers from the work of John W. Cahn. Dr. Cahn is Senior Fellow at the Materials Science and Engineering Laboratory of the National Institute of Standards and Technology, and is widely recognized as a founder of modern theory and thought in materials science. The range of his research included kinetics and mechanisms of metallurgical phase changes, surfaces, interfaces, defects, quasicrystals, thermodynamics, and other areas impacting the fundamental understanding of materials science.

Each paper includes a 2-4 page review of the impact and historical perspective of the work. This is an important collection for scientists, instructors and students interested in materials science.

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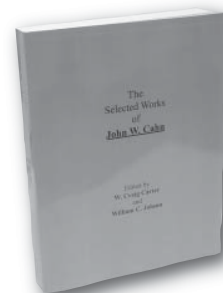
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For more details on these titles, including online tables of contents, visit the TMS Document Center at <http://doc.tms.org>.

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E-mail publications@tms.org

Online <http://doc.tms.org>

AWARDS

STUDENT AWARDS

The top five percent of student papers presented at EMC receive awards. Winning students receive \$500 awarded by TMS' Electronic Materials Committee. Student papers are judged on both scientific content and oral presentation at the conference. Awards are presented during the plenary session on Wednesday, June 22.

2005 JOHN BARDEEN AWARD WINNER

The John Bardeen Award, established in 1994, recognizes an individual who has made outstanding contributions and is a leader in the field of electronic materials.

Recipient: Arthur C. Gossard

Citation: For outstanding contributions and leadership to the materials science of epitaxial crystal growth and to the physics of electronic structure and devices.

Arthur Gossard is a professor at the University of California, Santa Barbara. He graduated summa cum laude from Harvard University in 1956 with a bachelor of arts and earned a doctorate from the University of California, Berkeley in 1960, both in physics. Prior to joining the University of California in 1987, Professor Gossard was a distinguished member of the technical staff at AT&T Bell Laboratories (1960–1987).

Among his many honors, he was elected to the National Academy of Sciences in 2001, named a Fellow of the Institute of Electrical and Electronic Engineers in 2001, and received the American Physical Society McGroddy Prize for New Materials in 2001.

"It is an honor to join the very distinguished ranks of the previous recipients of the John Bardeen Award. I am pleased by the recognition from TMS and my colleagues and by what this represents. It is very special to be associated with an award that recognizes the name of John Bardeen and his many contributions to both physics and electronic materials and devices."



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**PRELIMINARY SCHEDULE OF EVENTS
47TH TMS ELECTRONIC
MATERIALS CONFERENCE**

TUESDAY, JUNE 21, 2005

Registration.....3:00 PM – 5:00 PM
Location..... Multicultural Lounge

WEDNESDAY, JUNE 22, 2005

Registration.....7:30 AM – 5:00 PM
Location.....Multicultural Lounge
Exhibition9:20 AM – 4:00 PM & 6:00 PM – 8:00 PM
Location.....University Center/Lagoon Plaza
Welcome Reception6:00 PM – 8:00 PM
Location..... University Center/Lagoon Plaza

SESSIONS

Plenary Session8:20 AM
(Including Student Awards Ceremony)
Location.....Corwin Pavilion
Session A. Group III-Nitrides: Growth, Processing and
Characterization for Light-Emitting Diodes.....10:00 AM
Session B. Defects in Mismatched Semiconductor
Materials..... 10:00 AM
Session C. Contacts to Organic Semiconductors and
Device Performance..... 10:00 AM
Session D. Spintronics I - Dilute Magnetic Semiconductors..... 10:00 AM
Session E. High-K Gate Dielectrics I..... 10:00 AM
Session F. Dilute Nitrides I..... 10:00 AM
Session G. Non-Destructive Testing and In Situ
Monitoring and Control..... 10:00 AM
Joint DRC/EMC Invited Session.....1:30 PM
Session H. Processing of Nitrides for Electronic Devices..... 1:30 PM
Session I. ZnO: Doping and Devices..... 1:30 PM
Session J. Spintronics II - Spin-Dependent Electronic
Materials..... 1:30 PM
Session K. High-K Gate Dielectrics II..... 1:30 PM
Session L. Dilute Nitrides II..... 1:30 PM
Session M. Narrow Bandgap Semiconductors..... 1:30 PM

THURSDAY, JUNE 23, 2005

Registration.....7:30 AM – 4:00 PM
Location..... Multicultural Lounge
Exhibition10:00 AM – 4:00 PM
Location..... University Center/Lagoon Plaza
Conference Banquet6:00 PM – 9:00 PM
Location..... Natural History Museum

SESSIONS

Session N. Group III-Nitride Growth..... 8:20 AM
Session O. ZnO: Impurities and Characterization..... 8:20 AM
Session P. Dielectric/Semiconductor Interfaces and
Non-Ideal Behavior in Organic Transistors..... 8:20 AM

<i>Session Q.</i> Semiconductor Nanowires.....	8:20 AM
<i>Session R.</i> Si-Based Heterojunctions and Strained Si: Growth, Characterization, and Applications.....	8:20 AM
<i>Session S.</i> Materials Integration: Wafer Bonding and Alternative Substrates.....	8:20 AM
<i>Session T.</i> Basic and Applied Optical Properties of Quantum Dots.....	8:20 AM
<i>Session U.</i> IR Quantum Dots and Wells.....	10:20 AM
<i>Session V.</i> Group III-Nitrides: Characterization, Defects, and Ordering.....	1:30 PM
<i>Session W.</i> ZnO: Nanostructures.....	1:30 PM
<i>Session X.</i> Flexible Thin-Film Electronics.....	1:30 PM
<i>Session Y.</i> Nanotubes and Nanowires.....	1:30 PM
<i>Session Z.</i> Chemical and Biological Sensors: Materials, Interfaces, and Integration.....	1:30 PM
<i>Session AA.</i> Lattice-Engineered Materials and Devices.....	1:30 PM
<i>Session BB.</i> Wide Bandgap Wells, Wires, and Dots.....	1:30 PM

FRIDAY, JUNE 24, 2005

Registration.....	7:30 AM – 10:00 AM
Location.....	Multicultural Lounge

SESSIONS

<i>Session CC.</i> Bulk GaN.....	8:20 AM
<i>Session DD.</i> Properties of Nitrides for Electronics.....	10:20 AM
<i>Session EE.</i> ZnO: Thin-Film and Bulk Growth.....	8:20 AM
<i>Session FF.</i> Contacts to Semiconductor Structures.....	8:20 AM
<i>Session GG.</i> Silicon Carbide: Growth, Processing, and Characterization.....	8:20 AM
<i>Session HH.</i> Molecular Electronics.....	8:20 AM
<i>Session II.</i> InN and In-Rich Nitrides.....	8:20 AM
<i>Session JJ.</i> Epitaxial Quantum Dot Growth and Properties.....	8:20 AM
<i>Session KK.</i> Structure and Optical Properties of Complexes and Quantum Dots.....	10:20 AM
<i>Session LL.</i> Group III-Nitrides: Non-Polar Structures.....	1:30 PM
<i>Session MM.</i> Nanocharacterization.....	1:30 PM
<i>Session NN.</i> Epitaxy for Devices.....	1:30 PM

2005 Electronic Materials Conference

EMC Plenary Lecture/Student Awards

Ceremony: 8:20 AM

Room: Corwin Pavilion

Plenary Speaker: *Prof. Angela Belcher, Massachusetts Institute of Technology*

Topic: *A Genetic Toolkit for the Synthesis and Assembly of Electronic Materials*

Break: 9:20 AM

Joint DRC/EMC Invited Session

Wednesday PM
June 22, 2005

Room: Lotte Lehmann
Location: Music Hall

Session Chair: Theresa Mayer, Pennsylvania State University

1:30 PM Invited

Semiconductor Nanowires as a Novel Electronic Materials Technology for Future Electronic Devices: *L. Samuelson¹; ¹Lund University*

2:10 PM Invited

Nanocrystal Lasing in the Single-Exciton Regime Using Engineered Exciton-Exciton Interactions: *V. I. Klimov¹; S. Ivanov¹; J. Nanda¹; I. Bezel¹; M. Achermann¹; L. P. Balet¹; ¹Los Alamos National Laboratory*

2:50 PM Invited

Electric Field Effect Transport in Mesoscopic Graphite and Graphene: *Philip Kim¹; ¹Columbia University*

Session A:

Group III-Nitrides: Growth, Processing and Characterization for Light-Emitting Diodes

Wednesday AM
June 22, 2005

Room: Corwin Pavilion
Location: University Center

Session Chairs: Russell Dupuis, Georgia Institute of Technology;
Andrew Allerman, Sandia National Laboratories

10:00 AM Student

A1, Optimization of InGaN/GaN LED External Efficiency Using ITO p-Current-Spreading Layer Prepared by E-Beam Evaporation: *Jian*

Feng¹; Chak Wah Tang¹; Yun Dong Qi¹; Kei May Lau¹; ¹Hong Kong University of Science and Technology

10:20 AM

A2, Growth and Characterization of High-Quality Al_xGa_{1-x}N Multiple-Quantum-Well Structures for 280nm Deep-UV LEDs: Peng Li¹; Jae Limb¹; Jae-Hyun Ryou¹; Dongwon Yoo¹; Shichi Kubo¹; Theodore Chung¹; Russell Dupuis¹; Pete Cherns²; Colin Humphreys²; Yiping He³; Arto Nurmikko³; ¹Georgia Institute of Technology; ²University of Cambridge; ³Brown University

10:40 AM

A3, Double Heterostructure UV LEDs Based on Carrier Localization in MBE-Grown AlGaIn: Charles J. Collins¹; Anand V. Sampath¹; Gregory A. Garrett¹; H. Shen¹; Michael Wraback¹; Eric D. Readinger²; ¹U.S. Army Research Laboratory; ²University of Maryland

11:00 AM

A4, Photocurrent and Capacitance Studies of Polarization Fields and Charge Storage in InGaN/GaN SQW LEDs: Robert J. Kaplar¹; Steven R. Kurtz¹; Daniel D. Koleske¹; Arthur J. Fischer¹; ¹Sandia National Laboratories

11:20 AM Student

A5, Effect of Gallium Precursor on InGaN/GaN Multi-Quantum-Wells and Mg-Doped Layer for Green LEDs: Wonseok Lee¹; Jae Limb¹; Jae-Hyun Ryou¹; Dongwon Yoo¹; Theodore Chung¹; Russell Dupuis¹; ¹Georgia Institute of Technology

11:40 AM Student

A6, Optimized Doping and Contact Scheme for Low Voltage 275 nm Deep Ultraviolet LEDs: Craig Moe¹; Hisashi Masui¹; Arpan Chakraborty¹; Kenneth Vampola¹; Matthew Schmidt¹; Scott Newman¹; Likun Shen¹; Brendan Moran¹; Stacia Keller¹; Steve DenBaars¹; David Emerson²; ¹University of California, Santa Barbara; ²Cree, Inc.

Session B: Defects in Mismatched Semiconductor Materials

Wednesday AM Room: Flying A
June 22, 2005 Location: University Center

Session Chairs: David M. Wilt, NASA Glenn Research Center; William Hoke, Raytheon Company

10:00 AM Student

B1, Study of Defect Density in Lattice Mismatched In_{0.75}Al_{0.25}As/GaP Avalanche Photodiode: Abigail Lubow¹; Aristo Yulius¹; Hironori Tsukamoto¹; Jerry M. Woodall²; ¹Yale University; ²Purdue University

10:20 AM Student

B2, 2 μm Laser on Si(100) using AlSb Quantum Dot Nucleation: Ganesh Balakrishnan¹; Shenghong Huang¹; Arezou Khoshakhlagh¹; Paul Rotella¹; Abdenour Amtout¹; Ralph Dawson¹; Sanjay Krishna¹; Diana Huffaker¹; ¹University of New Mexico

10:40 AM

B3, Challenges in Epitaxial Growth of SiGe Buffers on Si (111), (110), and (112): Minjoo Larry Lee¹; Dimitri Antoniadis¹; Eugene A. Fitzgerald¹; ¹Massachusetts Institute of Technology

11:00 AM Student

B4, Deep Level Defects in GaAs Grown on Metamorphic SiGe Substrates and Evidence for Dislocation-Enhanced Point Defect Gettering: Maria Gonzalez¹; Carrie L. Andre¹; Matthew R. Lueck¹; Robert J. Walters²; Scott R. Messenger²; Jeffrey H. Warner²; Justin R. Lorentzen²; Eugene A. Fitzgerald³; Steven A. Ringel¹; ¹Ohio State University; ²Naval Research Laboratory; ³Massachusetts Institute of Technology

11:20 AM Student

B5, Conductivity of InAs Nanorods Grown in GaAs Via Holes: Kangho Lee¹; Ajit K. Mahapatro¹; Aristo Yulius²; Eric Harmon³; David B. Janes¹; Jerry M. Woodall¹; ¹Purdue University; ²Yale University; ³LightSpin Technologies, Inc.

Session C: Contacts to Organic Semiconductors and Device Performance

Wednesday AM Room: Lotte Lehmann
June 22, 2005 Location: Music Hall

Session Chairs: Alberto Salleo, Palo Alto Research Center; Lisa M. Porter, Carnegie Mellon University

10:00 AM Student

C1, Characterization and Improvement of Electrical Contacts to Novel n-Channel Organic Transistors: Byungwook Yoo¹; Antonio Facchetti²; Siddharth Mohapatra³; Myung-Han Yoon²; Klaus Dimmler³; Tobin Marks²; Ananth Dodabalapur¹; ¹University of Texas at Austin; ²Northwestern University; ³OrganicID

10:20 AM Student

C2, Nonlinear Charge Injection in Organic Field-Effect Transistors: Behrang H. Hamadani¹; Douglas Natelson¹; ¹Rice University

10:40 AM Student

C3, Influence of Electrode Contamination on α-NPD/Electrode Hole-Injection Barriers: Alan Shu-Chung Wan¹; Jaehyung Hwang¹; Fabrice Amy¹; Antoine Kahn¹; ¹Princeton University

11:00 AM

C4, Electronic Polarization at the Gold/Pentacene Interface: Fabrice Amy¹; Calvin Chan¹; Antoine Kahn¹; ¹Princeton University

11:20 AM

C5, High Mobility PTCDI-Based n-Channel TFTs and Complementary Inverters: David J. Gundlach¹; Kurt Pernstich¹; Mathias Grueter¹; Georg Wilckens¹; Bertram Batlogg¹; ¹Eidgenossische Technische Hochschule

Session D: Spintronics I - Dilute Magnetic Semiconductors

Wednesday AM Room: Multicultural Theater
June 22, 2005 Location: Multicultural Center

Session Chairs: Nitin Samarth, Pennsylvania State University;
Bruce W. Wessels, Northwestern University

10:00 AM Student

D1, Nanoengineered Curie Temperature in Laterally-Patterned Ferromagnetic Semiconductor Heterostructures: *B. L. Shew*¹; K. F. Eid¹; O. Maksimov¹; M. B. Stone²; P. Schiffer¹; Nitin Samarth¹; ¹Pennsylvania State University; ²Oak Ridge National Laboratory

10:20 AM Student

D2, Effect of Nitrogen Incorporation in Ferromagnetic (Ga,Mn)As Epilayers: *Itaru Oshiyama*¹; Tsuyoshi Kondo¹; Hiroo Munekata¹; ¹Tokyo Institute of Technology

10:40 AM

D3, Band Structure Model for Magnetic Coupling in Semiconductors: *Gustavo Martini Dalpian*¹; Su-Huai Wei¹; ¹National Renewable Energy Laboratory

11:00 AM

D4, Magnetic Property Investigations on MBE-Grown ZnMnO Layers: Augustine Che Mofor¹; Abdel-Hamid El-Shaer¹; Andrey Bakin¹; *Andreas Waag*¹; Heiko Ahlers²; Uwe Siegner²; Wladimir Schoch³; Natalija Izyumskaya³; Vitaliy Avrutin³; Sergey Sorokin⁴; Sergey Ivanov⁴; Johannis Stoimenos⁵; ¹Technical University Braunschweig; ²Physikalisch-Technische Bundesanstalt; ³University Ulm; ⁴Toffe Phys.-Tech. Institute; ⁵Aristotele University Thessaloniki

11:20 AM

D5, Electronic Structure of Transition Metal Impurities in ZnO: *Leon Petit*¹; ¹Oak Ridge National Laboratory

11:40 AM

D6, Late News

Session E: High-K Gate Dielectrics I

Wednesday AM Room: SB Harbor
June 22, 2005 Location: University Center

Session Chairs: Susanne Stemmer, University of California;
Evgeni Gusev, IBM Corporation

10:00 AM

E1, Improvement of Dielectric Properties of ZrO₂ Thin Films by Plasma Nitriding / Cathodic Arc Deposition: *Anping Huang*¹; Ricky K.Y. Fu¹; Zengfeng Di¹; Paul K. Chu¹; ¹City University of Hong Kong

10:20 AM

E2, Mixed TiO₂ and SiO₂ by PECVD: Physical, Optical and Electrical Characterization: *Tito Busani*¹; Roderick Devine¹; ¹CHTM/UNM

10:40 AM Student

E3, The Growth and Characteristics of ZrO₂ Gate Oxides for SiGe Metal-Oxide-Semiconductor Devices: Sang Yul Baek¹; Jae Sung Hur¹; Jeong-Seop Lee¹; In-Hoon Choi¹; ¹Korea University

11:00 AM Student

E4, Microstructure and Electronic Structure at ZrO₂/Silicon Interface: *Y. F. Dong*¹; S. J. Wang²; Y. P. Feng¹; A. C.H. Huan²; ¹National University of Singapore; ²Institute of Materials Research & Engineering

11:20 AM

E5, Epitaxial Growth of Artificial SrTiO₃/BaTiO₃ Superlattices on TiN Buffered Si Substrates by Pulsed Laser Deposition: Tae-Un Kim¹; Jong-Ha Moon¹; Byung-Teak Lee¹; Won Jae Lee²; Hong Seung Kim³; *Jin Hyeok Kim*¹; ¹Chonnam National University; ²Donggeui University; ³Korea Maritime University

11:40 AM

E6, Prolonging the Usage of Conventional NO Storage Dielectric by N₂O Wet Oxidation and Treatment for Trench DRAM: *Yung-Hsien Wu*¹; Hwei-Lin Chuang²; Sierra Lai¹; P. B. Wei¹; R. J. Wu¹; ¹ProMOS Technologies Inc.; ²United Microelectronics Corporation

Session F: Dilute Nitrides I

Wednesday AM Room: State Street
June 22, 2005 Location: University Center

Session Chairs: Thomas F. Kuech, University of Wisconsin;
Charles W. Tu, University of California

10:00 AM

F1, Quantitative Structural Analysis and Optimization of (GaIn)(NAs)/GaAs: Kerstin Volz¹; Torsten Torunski¹; Oleg Rubel¹; David Lackner¹; Wolfgang Stolz¹; ¹Philipps University Marburg

10:20 AM

F2, Annealing Behaviour of N Containing III/V-Semiconductors: Torsten Torunski¹; Oleg Rubel¹; Wolfgang Stolz¹; Kerstin Volz¹; Peer Kruse²; Dagmar Gerthsen²; Marco Schowalter³; Andreas Rosenauer³; ¹Philipps-University Marburg; ²University of Karlsruhe; ³University of Bremen

10:40 AM Student

F3, Band Offset Analysis of Dilute Nitride Single Quantum Well Structures Employing Surface Photo Voltage Measurements: Massimo Galluppi¹; Lutz Geelhaar¹; Henning Riechert¹; ¹Infineon Technologies AG

11:00 AM Student

F4, Study of Electronic Properties in GaN_xAs_{1-x} Probed by Persistent Photoconductivity Measurement: Shuo-Hsien Hsu¹; Yan-Kuin Su¹; Shou-Jinn Chang¹; Ricky W. Chuang¹; Wei-Cheng Chen¹; ¹National Cheng Kung University

11:20 AM

F5, Correlation Between Electron Trap and Degradation of GaNAs Solar Cells: Sarah Kurtz¹; Steve Johnston¹; Aaron Ptak¹; ¹National Renewable Energy Laboratory

11:40 AM

F6, Late News

Session G: Non-Destructive Testing and In Situ Monitoring and Control

Wednesday AM Room: Lobero
June 22, 2005 Location: University Center

Session Chairs: Andrew M. Hoff, University of South Florida; Kurt G. Eyink, Air Force Research Laboratory

10:00 AM

G1, GaSb(001) Surface Kinetics During Molecular Beam Epitaxy: Brad P. Tinkham¹; Wolfgang Braun¹; Vladimir M. Kaganer¹; Dillip K. Satapathy¹;

Bernd Jenichen¹; Brian R. Bennett²; Klaus H. Ploog¹; ¹Paul Drude Institute for Solid State Electronics; ²Naval Research Laboratory

10:20 AM Student

G2, In-Situ Investigation of Surface Stoichiometry During InGaN and GaN Growth by Plasma-Assisted Molecular Beam Epitaxy Using RHEED-TRAXS: Brenda VanMil¹; Randy P. Tompkins¹; Kyoungnae Lee¹; David Lederman¹; Thomas H. Myers¹; ¹West Virginia University

10:40 AM Student

G3, Spectroscopic Ellipsometry for Monitoring the Synthesis of GaN by Plasma-Assisted Molecular Beam Epitaxy: Soojeong Choi¹; Tong-Ho Kim¹; Michael Morse¹; Pae Wu¹; April Brown¹; Maria Losurdo²; Giovanni Bruno²; Akihiro Moto³; ¹Duke University; ²Institute of Inorganic Methodologies and of Plasmas; ³Innovation Core SEI, Inc.

11:00 AM

G4, Phonons and Plasmons in Doped ZnO and ZnO Based Alloys: Carsten Bundesmann¹; Mathias Schubert¹; Holger von Wenckstern¹; Daniel Spemann¹; Evgeni M. Kaidashev¹; Michael Lorenz²; Marius Grundmann¹; ¹Universitaet Leipzig

11:20 AM

G5, Novel Low Coherence Interferometry for In-Situ Characterization of Bonded Wafers: Wojtek J. Walecki¹; Alexander Pravidtsev¹; Kevin Lai¹; Talal Azfar¹; Manuel Santos¹; Mihail Mihaylov¹; Ann Koo¹; ¹FSM

Session H: Processing of Nitrides for Electronic Devices

Wednesday PM Room: Corwin Pavilion
June 22, 2005 Location: University Center

Session Chairs: Andrew Allerman, Sandia National Laboratories;
Jung Han, Yale University

1:30 PM Student

H1, In Situ-Grown Ultra-Thin Si₃N₄ Passivation and Gate Dielectric Layers for AlGaIn/GaN Insulating Gate HFET: Wenfei Wang¹; Joff Derluyn¹; Maarten Leys¹; Marianne Germain¹; Dominique Schreurs¹; Gustaaf Borghs¹; ¹IMEC

1:50 PM Student

H2, A Comparative Study of Surface Passivation Effects on DC Characteristics of AlGaIn/GaN HEMTs: Chang Liu¹; Eng Fong Chor¹; Leng Seow Tan¹; ¹National University of Singapore

2:10 PM

H3, Surface Leakage Currents and Peripheral Charging in Nanometer-Scale Schottky Gates of AlGaIn/GaN Heterostructure Transistors: Seiya Kasai¹; Junji Kotani¹; Tamotsu Hashizume¹; Hideki Hasegawa¹; ¹Hokkaido University

2:30 PM

H4, Novel Oxide Passivation of AlGaIn/GaN High Electron Mobility Transistor and Reliability of Passivation: Brent P. Gila¹; M. Hlad¹; T. Anderson¹; A. H. Onstine¹; R. Frazier¹; G. T. Thaler¹; A. Herrero¹; E.

Lambers¹; C. R. Abernathy¹; S. J. Pearton¹; N. Moser²; R. Fitch²; F. Ren¹; ¹University of Florida; ²Air Force Research Laboratory

2:50 PM

H5, High-Temperature Behaviors of Strain in Al_xGa_{1-x}N/GaN Heterostructures With and Without Si₃N₄ Surface Passivation: *Chen Dunjun¹*; Shen Bo²; Zhang Rong¹; Zheng Youdou¹; ¹Nanjing University; ²Peking University

3:10 PM Break

3:30 PM

H6, Deeply Recessed Thick Capped AlGaIn/GaN HEMTs with Epitaxial Field Plates: *Likun Shen¹*; Sten Heikman¹; Arpan Chakraborty¹; Stacia Keller¹; Umesh Mishra¹; ¹University of California

3:50 PM

H7, Low Temperature Mo/Al/Mo/Au Ohmic Contacts for AlGaIn/GaN HEMTs: *Anirban Basu¹*; Fitihi Mohammed¹; Ilesanmi Adesida¹; Shiping Guo²; Brian Albert²; Boris Peres²; Ivan Eliashevich²; ¹Micro and Nanotechnology Laboratory; ²EMCORE Corporation

4:10 PM

H8, Excellent Surface Morphology and Low Contact Resistivity of Si/Ti/Al/Mo/Au Ohmic Contacts for Undoped-AlGaIn/GaN HFETs: *Ho-Young Cha¹*; X. Chen¹; Y.-J. Sun¹; H. Wu¹; W. J. Schaff¹; M. G. Spencer¹; L. F. Eastman¹; ¹Cornell University

4:30 PM Student

H9, Study of Si Diffused GaN for Enhancement-Mode MOSFET Applications: *SooHwan Jang¹*; Brent P. Gila¹; Hyuksu Yang¹; Stephen Pearton¹; Fan Ren¹; ¹University of Florida

4:50 PM Student

H10, Digital Etching of III-N Materials Using a Two-Step Ar/KOH Technique: *David Keogh¹*; Russell Dupuis²; Milton Feng³; Peter M. Asbeck¹; ¹University of California, San Diego; ²Georgia Tech; ³University of Illinois

Session I: ZnO: Doping and Devices

Wednesday PM Room: Flying A
June 22, 2005 Location: University Center

Session Chairs: Julia W.P. Hsu, Sandia National Laboratories;
Yicheng Lu, Rutgers University

1:30 PM Student

I1, Realization of Phosphorus-Doped p-Type (Zn,Mg)O Thin Films via Pulsed Laser Deposition: *Yuan-Jie Li¹*; YoungWoo Heo¹; Jean Marie Erié¹; Hyunsik Kim¹; Kelly Ip¹; Steven J. Pearton¹; David P. Norton¹; Jaujun Chen¹; Fan Ren¹; ¹University of Florida

1:50 PM

I2, Impact of As-Doping on the Optical Properties of ZnO: Isolation and Identification of a New As-Acceptor Related Emission Line: *Frank Bertram¹*; J. Christen¹; S. Giemsch¹; A. Dadgar¹; A. Krost¹; ¹Otto-von-Guericke-University Magdeburg

2:10 PM

I3, Heteroepitaxial and Homoepitaxial Growth and Nitrogen Doping of Dense ZnO Films via MOVPE and a Low/High Temperature Sequence: *Robert F. Davis¹*; ¹Carnegie Mellon University

2:30 PM

I4, Analysis of the Objectionable n-Background Conductivity in ZnO Crystals: *Peter Kiesel¹*; Oliver Schmidt¹; Chris G. van de Walle²; Noble Johnson¹; ¹Palo Alto Research Center; ²University of California, Santa Barbara

2:50 PM Student

I5, Ab Initio Study of Polarization and Piezoelectric Constants of the Binary Oxide System ZnO, MgO, CdO and Its Related Alloys: *Priya Gopal¹*; ¹University of California, Santa Barbara

3:10 PM Break

3:30 PM

I6, Fabrication of ZnMgO:P/ZnO p-n Junctions on ZnO Substrates: *Hyucksoo Yang¹*; Yuanjie Li¹; David Norton¹; Stephen Pearton¹; Soohwan Jang¹; Fan Ren¹; Lynn Boatner²; ¹University of Florida; ²Oak Ridge National Laboratory

3:50 PM Student

I7, Dynamic and Static Photoresponse in n-ZnO/p-Si Photodiode vs. n-ZnO Based Thin-Film Transistors: *Heesun Bae¹*; Kimoon Lee¹; Seongil Im¹; ¹Yonsei University

4:10 PM Student

I8, Growth, Fabrication and Characterization of ZnO Based Single Nanorod Field Effect Transistor: *Byoung Sam Kang¹*; Lichia Tien¹; Patrick Sadik¹; Youngwoo Heo¹; David Norton¹; Stephen Pearton¹; Fan Ren¹; ¹University of Florida

4:30 PM Student

I9, Highly Sensitive Hydrogen Sensor Using Pd Nanoparticles Coated ZnO Nanorods: *Hung-Ta Wang¹*; Byoung Sam Kang¹; Li-Chia Tien¹; Patrick Sadik¹; David Norton¹; Stephen Pearton¹; Fan Ren¹; ¹University of Florida

4:50 PM

I10, Late News

Session J: Spintronics II - Spin-Dependent Electronic Materials

Wednesday PM Room: Multicultural Theater
June 22, 2005 Location: Multicultural Center

Session Chairs: Michael E. Flatté, University of Iowa; Chris J. Palmstrom, University of Minnesota

1:30 PM Student

J1, Mechanical Stress Induced Instabilities in Tunnel Magneto Resistance Devices: *Pawan Tyagi¹*; Bruce J. Hinds¹; ¹University of Kentucky

1:50 PM

J2, Spin Gunn Effect: *Yunong Qi*¹; Zhi-Gang Yu¹; Michael E. Flatté¹;
¹University of Iowa

2:10 PM Student

J3, Spin Injection from the Heusler Alloy Co₂MnGe into Al_{0.1}Ga_{0.9}As/GaAs Heterostructures: *Xuying Dong*¹; Xiaohua Lou¹; Christoph Adelmann¹; Jonathan Strand¹; Amanda Petford-Long²; Paul Crowell¹; Chris Palmström¹; ¹University of Minnesota; ²University of Oxford

2:30 PM

J4, Ballistic Electron Transport in Spin Valve Transistors Studied by Scanning Tunneling Microscopy Techniques: *Rudolf Heer*¹; Jürgen Smoliner²; Jan Bornemeier³; Hubert Brückl¹; ¹ARC Seibersdorf; ²TU-Wien; ³Universität Bielefeld

2:50 PM

J5, Bi-Stable Current Voltage Characteristics Persistently Observed in an In₈₁Ga₁₉As Channel Spin Transistor with Fe Electrodes as Spin Injector/Detector: *Kanji Yoh*¹; Marhoun Ferhat¹; Joanna M. Millunchick²; ¹Hokkaido University, Japan Science and Technology Agency; ²University of Michigan

3:10 PM

J6, Electric Field Driven Spin Resonances of a Magnetic Dopant in a Semiconductor: *Jian-Ming Tang*¹; Jeremy Levy²; Michael E. Flatté¹; ¹University of Iowa; ²University of Pittsburgh

3:30 PM Break

3:50 PM Student

J7, Metalorganic Vapor Phase Epitaxy of MnAs Thin Films and Their Ferromagnetic Properties: *George Evan Sterbinsky*¹; Steven J. May¹; Philip T. Chiu¹; Bruce W. Wessels¹; ¹Northwestern University

4:10 PM Student

J8, Exchange Biasing of the Ferromagnetic Semiconductor (Ga,Mn)As: *K. F. Eid*¹; M. B. Stone¹; O. Maksimov¹; K. C. Ku¹; T. C. Shih²; C. J. Palmström²; P. Schiffer¹; Nitin Samarth¹; ¹Pennsylvania State University; ²University of Minnesota

4:30 PM Student

J9, Electric Field Dependence of the G Tensor of MBE-Grown Semiconductor Quantum Dots: *Joseph Pinget*¹; Craig E. Pryor¹; Michael E. Flatté¹; ¹University of Iowa

4:50 PM

J10, Late News

Session K: High-K Gate Dielectrics II

Wednesday PM

June 22, 2005

Room: SB Harbor

Location: University Center

Session Chairs: Patrick Lenahan, Pennsylvania State University; Susanne Stemmer, University of California

1:30 PM Student

K1, Scanning Transmission Electron Microscopy Investigation of HfO₂/TiN Interfaces in High-*k* Gate Stacks: *Melody Pacifico Agustin*¹; Leonardo R.L. Fonseca²; Jacob Hooker³; Susanne Stemmer¹; ¹University of California, Santa Barbara; ²Freescale Semiconductor; ³Philips Research Leuven

1:50 PM Student

K2, Effect of Precursor Chemistry on the Composition, Structure and Electrical Properties of Ultra-Thin ALD-HfO₂ Gate Dielectrics: *Raghavasimhan Sreenivasan*¹; Hyounsub Kim¹; Paul McIntyre¹; Krishna Saraswat¹; ¹Stanford University

2:10 PM Student

K3, The Effect of Nitrogen Incorporation on the Material and Electrical Properties of HfO₂ on Si: *Monica Sawkar*¹; Jongwoo Choi¹; Ragesh Puthenkovilakam¹; Jane P. Chang¹; ¹University of California, Los Angeles

2:30 PM Student

K4, Interface Defects in Si/HfO₂-Based Metal-Oxide-Semiconductor Field-Effect Transistors: *Thomas George Pribicko*¹; Jason Campbell¹; Patrick Lenahan¹; Wilman Tsai²; Andreas Kerber³; ¹Pennsylvania State University; ²Intel; ³Infineon Technologies AG

2:50 PM Student

K5, Electron Paramagnetic Resonance Studies of Hafnium Oxide MOS Structures: *Jason Thomas Ryan*¹; Patrick M. Lenahan¹; Tom G. Pribicko¹; Gennadi Bersuker²; Pat Lysaght²; Joel Barnett²; John Conley³; ¹Pennsylvania State University; ²SEMATECH; ³Sharp Laboratories of America

3:10 PM Break

3:30 PM

K6, Combinatorial Characterization of Metal Gate/High-*k* Oxide Interface: *T. Chikyow*¹; P. Ahmet²; K. Nakajima²; T. Nagta¹; G. Richter³; T. Wagner³; ¹National Institute for Materials Science, CREST-Japan Science and Technology Corporation; ²National Institute for Materials Science; ³Max Plank Institute

3:50 PM

K7, Impact of Thickness of Metal Nitride (TiN) in Poly Si/TiN Gate Stack on Electrical Performance and Reliability: *Sang Ho Bae*¹; Seung-Chul Song¹; Zhibo Zhang²; Johnny Sim¹; Prashant Majhi³; Kisik Choi¹; Paul Kirsch⁴; Naim Moumen⁴; Byoung Hun Lee⁴; ¹Sematech; ²Sematech, Texas Instruments assignee; ³Sematech, Intel assignee; ⁴Sematech, IBM assignee

4:10 PM

K8, Imaging of Hafnium Atoms in Silicon Dioxide: *Dmitri O. Klenov*¹; Evgeni Gusev²; Paul Saunders²; Susanne Stemmer¹; ¹University of California; ²IBM

4:30 PM

K9, Atomic Layer Deposition (ALD) of Thin Ruthenium Films for Next Generation CMOS Metal Gate Electrode Applications: *Filippos Papadatos*¹; Steve Consiglio¹; Mihir Tungare¹; Kalyan Veranda¹; Nathaniel Berliner¹; Eric T. Eisenbraun¹; Alain E. Kaloyeros¹; ¹University at Albany, SUNY

4:50 PM

K10, Late News

Session L: Dilute Nitrides II

Wednesday PM
June 22, 2005

Room: State Street
Location: University Center

Session Chairs: Rachel S. Goldman, University of Michigan;
Wladek Walukiewicz, Lawrence Berkeley Laboratory

1:30 PM

L1, First Optical Pumped Lasing Operation of the Novel Ga(NAsP) Dilute Nitride Material System Pseudomorphically Grown on GaP Substrate by MOVPE: *Bernardette Kunert*¹; Torsten Torunski¹; Jörg Koch¹; Kerstin Volz¹; Sebastian Borck¹; Jörg Heber¹; Wolfgang W. Rühle¹; Wolfgang Stolz¹; ¹Philipps-University

1:50 PM

L2, 1.53-1.55 μ m Temperature-Tunable GaInNAsSb Laser Diodes Grown on GaAs(001): *James A. Gupta*¹; Pedro Barrios¹; Xia Zhang²; Greg Pakulski¹; Xiaohua Wu¹; ¹National Research Council of Canada; ²University of Ottawa

2:10 PM Student

L3, Characteristics of GaAsN/GaAsSb Type-II MQWs on GaAs Substrates Grown by Metalorganic Vapor Phase Epitaxy: *A. A. Khandekar*¹; B. E. Hawkins¹; T. F. Kuech¹; J. Y. Yeh¹; L. J. Mawst¹; J. R. Meyer²; I. Vurgaftman²; ¹University of Wisconsin; ²Naval Research Laboratory

2:30 PM Student

L4, Effects of Growth Temperature on the Optical Behavior of GaInNAsSb Alloys: *Seth R. Bank*¹; Homan B. Yuen¹; Mark A. Wistey¹; Vincenzo Lordi¹; Hopil Bae¹; James S. Harris¹; ¹Stanford University

2:50 PM Student

L5, Influence of Ion Flux and Ion Energy Distribution on the Optical Properties of Dilute Nitride Materials: *Michael M. Oye*¹; Mark A. Wistey²; Jason M. Reifsnider³; Sumit Agarwal⁴; Sridhar Govindaraju¹; Seth R. Bank²; Homan B. Yuen²; Terry J. Mattord¹; James S. Harris²; Gary A. Hallock¹; Archie L. Holmes¹; ¹University of Texas at Austin; ²Stanford University; ³Samsung Austin Semiconductor; ⁴University of Massachusetts-Amherst

3:10 PM

L6, Enhanced-Depletion-Width GaInNAs Solar Cells Grown by Molecular-Beam Epitaxy: *Aaron J. Ptak*¹; Daniel J. Friedman¹; Sarah Kurtz¹; James Kiehl¹; ¹National Renewable Energy Laboratory

3:30 PM Break

3:50 PM Student

L7, Ga(In)NP-Based Yellow-Red Light-Emitting Diodes Directly Grown on GaP (100) Substrates: *Vladimir A. Odnoblyudov*¹; Charles W. Tu¹; ¹University of California, San Diego

4:10 PM

L8, Investigations of GaN_xP_{1-x}/GaP LED Structure Optical Properties: *Lorant Peternai*¹; Jaroslav Kovac¹; Jan Jakabovic¹; Volker Gottschalch²; Bernd Rheinlaender²; ¹Slovak University of Technology Bratislava; ²University of Leipzig

4:30 PM

L9, Mid-Infrared Photoluminescence of Dilute Nitride InN_xAs_{1-x}/In_{0.53}Ga_{0.47}As/InP Multi-Quantum Wells: *Handong Sun*¹; Antony H. Clark¹; Stephan Calvez¹; Martin D. Dawson¹; D. K. Shih²; Hao-Hsiung Lin²; ¹University of Strathclyde; ²National Taiwan University

4:50 PM

L10, Strong Increase of the Electron Effective Mass in GaAs Incorporating Boron and Indium: *Tino Hofmann*¹; Mathias Schubert¹; Eoin O'Reilly²; ¹University of Leipzig; ²NMRC University College

Session M: Narrow Bandgap Semiconductors

Wednesday PM
June 22, 2005

Room: Lobero
Location: University Center

Session Chairs: Christine Wang, Massachusetts Institute of Technology; Robert M. Biefeld, Sandia National Laboratories

1:30 PM Student

M1, Mid-IR Photoluminescence from InGaSb QWs on GaAs: *Peter Hill*¹; L. Ralph Dawson¹; Paul Rotella¹; Sanjay Krishna¹; Philip Dowd¹; ¹University of New Mexico

1:50 PM Student

M2, InAs/GaSb SLS Infrared Photovoltaic Detectors Grown on GaAs Substrates: *Elena A. Plis*¹; Nina Weisse-Bernstein¹; Larry Ralph Dawson¹; Sanjay Krishna¹; ¹University of New Mexico

2:10 PM

M3, High-Quality InAs-GaSb Superlattices Grown by MOCVD on (001) GaAs Substrates for Mid-IR Photodetector Applications: *Xue-Bing Zhang*¹; Jae-Hyun Ryou¹; Russell Dupuis¹; Shin Mou²; Shun Lien Chuang²; C. Xu²; Kuang-Chien Hsieh²; ¹Georgia Institute of Technology; ²University of Illinois at Urbana-Champaign

2:30 PM

M4, Mid-Infrared "W" Diode Lasers Operating CW up to 218 K: William W. Bewley¹; J. Ryan Lindle¹; Chadwick L. Canedy¹; Igor Vurgaftman¹; *Chulsoo Kim*¹; Mijin Kim¹; Jerry R. Meyer¹; ¹Naval Research Laboratory

2:50 PM Student

M5, Type II Photoluminescence of InGaAlAs/GaAsSb Heterostructures Grown by Molecular Beam Epitaxy: *Houssam Chouaib*¹; Catherine Bru-

Chevallier¹; Philippe Bove²; ¹Laboratoire de Physique de la Matière; ²Picogiga

3:10 PM Student

M6, Density Functional Theory Studies of Al and Ga Diffusion in AlSb/GaSb Structures: *M. Gonzalez-Debs¹; A. A. Gokhale¹; M. Mavrikakis¹; T. F. Kuech¹; ¹University of Wisconsin*

3:30 PM Break

3:50 PM Student

M7, Shallow Ohmic Contacts to P-InAs: *Eric M. Lysczek¹; Joshua A. Robinson¹; Sammy H. Wang¹; Suzanne E. Mohney¹; ¹Pennsylvania State University*

4:10 PM Student

M8, InP Based Photodiodes Operating Beyond 2 μ m Using Lattice-Matched GaInAs-GaAsSb Type-II Quantum Wells: *Rubin Sidhu¹; Ning Duan¹; Joe C. Campbell¹; Archie L. Holmes¹; ¹University of Texas at Austin*

4:30 PM

M9, InAs Quantum Well Heterostructures for FETs with Ultra-Short Gates: *Brian R. Bennett¹; J. Brad Boos¹; Mario G. Ancona¹; Nicholas Papanicolaou¹; Doewon Park¹; Robert Bass¹; ¹Naval Research Laboratory*

4:50 PM

M10, Intersubband Transitions in HgTe/HgCdTe Superlattices and Deformation Potentials of the Semimetal HgTe: *Charles R. Becker¹; V. Latussek¹; G. Landwehr¹; R. Bini²; L. Ulivi²; ¹University Würzburg; ²European Lab for Nonlinear Spectroscopy*

Session N: Group III-Nitride Growth

Thursday AM
June 23, 2005

Room: Corwin East
Location: University Center

Session Chairs: Thomas Myers, West Virginia University;
Christiane Poblenz, University of California, Santa Barbara

8:20 AM

N1, Effect of Mg on the Structure and Growth of GaN(0001): *John E. Northrup¹; ¹Palo Alto Research Center*

8:40 AM

N2, Ga Adlayer Governed Surface Morphology Evolution of (0001) GaN Films Grown by Plasma-Assisted Molecular Beam Epitaxy: *Gregor Koblmüller¹; Jay Brown¹; Robert Averbeck²; Henning Riechert²; Peter Pongratz³; James Speck¹; ¹University of California, Santa Barbara; ²Infineon Technologies; ³Vienna University of Technology*

9:00 AM Student

N3, Effects of SiC Surface Modification on the Defect Structure of Molecular Beam Epitaxy Grown GaN: *Mike Morse¹; Pae Wu¹; April Brown¹; Tong-Ho Kim¹; Maria Losurdo²; Giovanni Bruno²; ¹Duke University; ²Institute of Inorganic Methodologies and of Plasmas-CNR, and INSTM*

9:20 AM Student

N4, Structural and Electrical Characterization of N-Face GaN Grown on C-Face SiC by MBE: *Siddharth Rajan¹; Feng Wu¹; Manhoi Wong¹; Yenyun Fu¹; James S. Speck¹; Umesh K. Mishra¹; ¹University of California, Santa Barbara*

9:40 AM

N5, Growth of AlGaN Alloys Exhibiting Enhanced Luminescence Efficiency: *Anand V. Sampath¹; Gregory A. Garrett¹; Charles J. Collins¹; Eric D. Readinger²; Wendy L. Sarney¹; H. Shen¹; Michael Wraback¹; ¹US Army Research Laboratory; ²University of Maryland*

10:00 AM Student

N6, Effect of AlN Nucleation Layer Growth Conditions on Buffer Leakage in AlGaIn/GaN High Electron Mobility Transistors Grown by Molecular Beam Epitaxy (MBE): *Christiane Poblenz¹; Patrick Waltereit¹; Siddharth Rajan¹; Umesh Mishra¹; James S. Speck¹; ¹University of California, Santa Barbara*

10:20 AM Break

10:40 AM Student

N7, High Quality AlN Layers Grown on (0001) Sapphire: *Seungjong Lee¹; Daewoo Kim¹; Subhash Mahajan¹; ¹Arizona State University*

11:00 AM Student

N8, Metalorganic Molecular Beam Epitaxy of Gallium Nitride: Towards an Understanding of Surface Reaction Chemistry: *David Pritchett¹; Shawn Burnham¹; Walter Henderson¹; W. Alan Doolittle¹; ¹Georgia Institute of Technology*

11:20 AM

N9, The Growth of GaN/InGaN HBTs by MOCVD: *Theodore Chung¹; Ben Chukung²; David Keogh³; Jae-Boum Limb¹; Jae-Hyun Ryou¹; Wonseok Lee¹; Peng Li¹; Dongwon Yoo¹; Xue-Bing Zhang¹; D. Zakharov⁴; Zusanne Lilienthal-Weber⁴; Peter Asbeck³; Milton Feng²; Shyh-Chiang Shen¹; Russell Dupuis¹; ¹Georgia Institute of Technology; ²University of Illinois at Urbana-Champaign; ³University of California, San Diego; ⁴Lawrence Berkeley National Laboratory*

11:40 AM

N10, Late News

Session O: ZnO: Impurities and Characterization

Thursday AM
June 23, 2005

Room: Corwin West
Location: University Center

Session Chairs: David P. Norton, University of Florida; David C. Look, Wright State University

8:20 AM Invited

O1, Important Impurities and Defects in ZnO: *David C. Look¹; ¹Wright State University*

9:00 AM

O2, Acceptor Clustering Related Free-to-Bound-Transition (e, A0) in ZnO: *J. Christen¹; Frank Bertram¹; S. Giemisch¹; Th. Hempel¹; S. Petzold¹;*

A. Dadgar¹; N. Oleynik¹; A. Krost¹; ¹Otto-von-Guericke-University Magdeburg

9:20 AM

O3, Electronic and Structural Properties of Native Point Defects in ZnO Revisited: *Anderson Janotti¹*; Chris G. Van de Walle¹; ¹University of California, Santa Barbara

9:40 AM

O4, High Quality Zinc Oxide Nanowires Grown on Silicon Dioxide by Metalorganic Chemical Vapor Deposition at Low Temperature: *Shizuo Fujita¹*; Sang-Woo Kim¹; ¹Kyoto University

10:00 AM Break

10:20 AM

O5, Ultrafast Exciton Dynamics in a ZnO Thin Film Studied with fs Pump-Probe Experiment and Time-Resolved Photoluminescence Spectroscopy: *Cheng-Yen Chen¹*; Fang-Yi Jen¹; Yen-Cheng Lu¹; Hsiang-Chen Wang¹; C. C. Yang¹; Bao-Ping Zhang²; Yusaburo Segawa²; ¹National Taiwan University; ²Institute of Physical and Chemical Research

10:40 AM

O6, Record Long Room-Temperature Spontaneous Emission Lifetime in ZnO Epilayers Grown by Laser-Assisted Molecular Beam Epitaxy on ScAlMgO₄ Substrates Using High-Temperature-Annealed Self-Buffer and Proper Defect Management: *Shigefusa F. Chichibu¹*; Atsushi Tsukazaki²; Takeyoshi Onuma¹; Akira Ohtomo²; Takayuki Sota³; Akira Uedono¹; Masashi Kawasaki²; ¹University of Tsukuba; ²Tohoku University; ³Waseda University

11:00 AM

O7, Exciton Binding Energy in a ZnO/MgZnO Quantum Well Structure: *Cheng-Yen Chen¹*; Fang-Yi Jen¹; Yen-Cheng Lu¹; Hsiang-Chen Wang¹; C. C. Yang¹; Bao-Ping Zhang²; Yusaburo Segawa²; ¹National Taiwan University; ²Institute of Physical and Chemical Research

11:20 AM Student

O8, Photoconductive Behavior of ZnO for Below Bandedge Excitation: *Kaveh Moazzami¹*; Timothy E. Murphy¹; Jamie D. Phillips¹; ¹University of Michigan

11:40 AM Student

O9, Infrared Absorption Characteristics of Bulk and Epitaxial ZnO and Relationship to Electronic Properties: *Pierre-Yves Emelie¹*; Kaveh Moazzami¹; Jeff Siddiqui¹; Song Liang Chua¹; Jamie Phillips¹; ¹University of Michigan

Session P: Dielectric/Semiconductor Interfaces and Non-Ideal Behavior in Organic Transistors

Thursday AM
June 23, 2005

Room: Lotte Lehmann
Location: Music Hall

Session Chairs: Michael D. McGehee, Stanford University; David J. Gundlach, Eidgenossische Technische Hochschule

8:20 AM Invited

P1, Chemical Effects on the Device Characteristics of Polymeric Thin-Film Transistors: *Michael L. Chabinyc¹*; ¹Palo Alto Research Center

9:00 AM Student

P2, Top-Gated Organic Field-Effect Transistors with Parylene Dielectric: *Christopher Robert Newman¹*; Matthew Panzer¹; C. Daniel Frisbie¹; ¹University of Minnesota

9:20 AM

P3, Pentacene TFT on a Room-Temperature Formed Organic Gate Insulator and Its Applications: Iwao Yagi¹; Jun Tanabe²; Keiichi Yanagisawa¹; Kazuhito Tsukagoshi³; Yoshinobu Aoyagi²; ¹RIKEN; ²RIKEN and Tokyo Tech.; ³RIKEN and PRESTO, JST

9:40 AM Student

P4, Low-Voltage Operation of a Pentacene Field-Effect Transistor Realized Using a Polymer Electrolyte Gate Dielectric: *Matthew J. Panzer¹*; Christopher R. Newman¹; C. Daniel Frisbie¹; ¹University of Minnesota

10:00 AM Break

10:20 AM Student

P5, Molecular *n*-Type Doping of 1,4,5,8-Naphthalene Tetracarboxylic Dianhydride (NTCDA) by Pyronin B (PyB): *Calvin K. Chan¹*; Eung-Gun Kim²; Jean-Luc Bredas²; Antoine Kahn¹; ¹Princeton University; ²Georgia Institute of Technology

10:40 AM

P6, Morphological Effects on Charge Transport in Conjugated Polymers: *Michael D. McGehee¹*; Joe Kline¹; ¹Stanford University

11:00 AM

P7, Anomalous Behavior of Low Temperature Mobility in Copper Phthalocyanine Thin Film: Niladri Sarkar¹; *Ajit Kumar Mahapatro²*; Subhasis Ghosh¹; ¹Jawaharlal Nehru University; ²Purdue University

11:20 AM

P8, Electrical Stress Induced Charged Defect Generation in P3HT Based Devices: *Maya N. Kutty¹*; Roderick A.B. Devine²; ¹University of New Mexico; ²Kirtland AFDB

11:40 AM

P9, Late News

Session Q: Semiconductor Nanowires

Thursday AM
June 23, 2005

Room: Multicultural Theater
Location: Multicultural Center

Session Chairs: Hou T. Ng, Hewlett-Packard Company; Timothy D. Sands, Purdue University

8:20 AM Student

Q1, *In Situ* Studies of Semiconductor Nanowire Growth Using Optical Reflectometry: *Teresa J. Clement*¹; S. Ingole¹; Jeff Drucker¹; S. T. Picraux¹; ¹Arizona State University

8:40 AM Student

Q2, Photoelectron Spectroscopic Studies of Passivation of Germanium Nanowires: *Hemant Adhikari*¹; Paul C. McIntyre¹; Christopher E.D. Chidsey¹; ¹Stanford University

9:00 AM

Q3, Heterostructure Formation and Strain Mapping in Si-Ge Nanowires: *J. L. Taraci*¹; M. J. Hÿtch²; T. Clement¹; David J. Smith¹; P. Peralta¹; M. R. McCartney¹; J. Shumway¹; Jeff Drucker¹; S. T. Picraux¹; ¹Arizona State University; ²Centre d'Etudes de Chimie Mÿtallurgique, Centre National de Recherche Scientifique

9:20 AM Student

Q4, Oxidation of Silicon Nanowires: *Daniel Shir*¹; Bangzhi Liu¹; Suzanne E. Mohny¹; Yanfeng Wang¹; James B. Mattzela¹; Theresa S. Mayer¹; Kok-Keong Lew¹; Joan M. Redwing¹; Soham Dey¹; Ahmad Mohammad¹; ¹Pennsylvania State University

9:40 AM Student

Q5, Synthesis and Electrical Characterization of p-n Junctions in Silicon Nanowires: *Kok-Keong Lew*¹; Yanfeng Wang¹; Bangzhi Liu¹; Suzanne E. Mohny¹; Theresa S. Mayer¹; Joan M. Redwing¹; ¹Pennsylvania State University

10:00 AM

Q6, InP Nanowire Photodetectors: *David Paul Richard Aplin*¹; Jenny R. Hu¹; Clint Novotny¹; Paul K.L. Yu¹; S. S. Lau¹; Deli Wang¹; ¹University of California, San Diego

10:20 AM Break

10:40 AM

Q7, Epitaxially Aligned GaN Nanowires and Nanobridges by MOCVD: Jie Su¹; Maria Gherasimova¹; George Cui¹; *Jung Han*¹; Christine Broadbridge²; Ann Lehman³; T. Onuma⁴; S. F. Chichibu⁴; Yiping He⁵; Arto Nurmikko⁵; ¹Yale University; ²Southern Connecticut State University; ³Trinity College; ⁴University of Tsukuba; ⁵Brown University

11:00 AM Student

Q8, Synthesis and Characterization of Indium Arsenide Nanowires: *Shadi Ahmad Dayeh*¹; David Aplin¹; Xiaotian Zhou¹; Paul Yu¹; Edward T. Yu¹; Deli Wang¹; ¹University of California, San Diego

11:20 AM Student

Q9, High Yield GaN Nanowire FET Fabrication and Characterization: *Huaqiang Wu*¹; Ho-Young Cha¹; Mvs Chandrashekar¹; Goutam Koley²; Michael G. Spencer¹; ¹Cornell University; ²University of South Carolina

11:40 AM

Q10, Late News

Session R: Si-Based Heterojunctions and Strained Si: Growth, Characterization, and Applications

Thursday AM
June 23, 2005

Room: SB Harbor
Location: University Center

Session Chairs: Minjoo Larry Lee, Massachusetts Institute of Technology; Ya-Hong Xie, University of California

8:20 AM

R1, High Quality Germanium Films Grown Directly on Si(001) by Surfactant Mediated Epitaxy: *Tobias F. Wietler*¹; Eberhard Bugiel¹; Rainer Kurps²; Karl R. Hofmann¹; ¹University of Hannover; ²IHP

8:40 AM Student

R2, Growth of Strain-Symmetried Si/SiGe Superlattice for THz Quantum Cascade Emitters Using MBE: *Ming Zhao*¹; Anders Elfving¹; Adnane Bouchaib¹; Wei-Xin Ni¹; Paul Townsend²; Stephen A. Lynch²; Douglas J. Paul²; Chiung-Chih Hsu³; Mao-Nan Chang³; ¹Linköping University; ²University of Cambridge; ³National Nano Device Laboratories

9:00 AM

R3, A New Post-Epitaxial Process for Straining Monocrystalline Si Thin Films Allowing a Direct Use for Device Applications or as a Virtual Substrate: *Marty Olivier*¹; Michel Pitaval¹; Tatiana Nychporuk²; Volodymyr Lysenko²; Daniel Barbier²; ¹LENaC - UCB Lyon1; ²LPM - INSA Lyon

9:20 AM Student

R4, Dislocation Free Strained-Si/SiGe Membranes: *Michelle M. Roberts*¹; Hao-Chih Yuan¹; D. E. Savage¹; Z. Q. Ma¹; M. G. Lagally¹; ¹University of Wisconsin-Madison

9:40 AM

R5, Assessment of Strained Silicon/SiGe with Different Architectures by Raman Spectroscopy: *Steve J. Bull*¹; Peter Dobrosz¹; Sarah Olsen¹; Anthony O'Neill¹; ¹University of Newcastle

10:00 AM

R6, Fowler-Nordheim Tunneling in Strained Si/SiGe MOS Devices: Impact of Cross-Hatching and Nanoscale Roughness: *Kelvin S.K. Kwa*¹; Sarah H. Olsen¹; Anthony G. O'Neill¹; Sanatan Chattopadhyay¹; Goutam Dalapati¹; Luke S. Driscoll¹; ¹University of Newcastle

10:20 AM Break

10:40 AM Student

R7, Gate Oxide Reliability Studies for Strained Si on Relaxed SiGe MOS Devices: *Sachin Joshi*¹; Doreen Ahmad¹; Marylene Palard¹; David Q. Kelly¹; David Onsongo¹; Sagnik Dey¹; L. Fei²; T. Torack²; Mike Seacrist²; Bruce Kellerman²; Sanjay K. Banerjee¹; ¹University of Texas at Austin; ²MEMC Electronic Materials Inc.

11:00 AM Student

R8, Ge_{1-y}C_y MOS Capacitors with HfO₂ Gate Dielectric and TaN Gate: *David Quest Kelly*¹; Joseph Patrick Donnelly¹; Sagnik Dey¹; Sachin Vineet Joshi¹; Sanjay K. Banerjee¹; ¹University of Texas at Austin

11:20 AM Student

R9, Theoretical Study of Boron Diffusion in Strained Si: *Li Lin*¹; Taras Kirichenko¹; Bhagawan Sahu¹; Joo Hwan Yoo¹; Sanjay Banerjee¹; ¹University of Texas-Austin

11:40 AM

R10, Late News

Session S: Materials Integration: Wafer Bonding and Alternative Substrates

Thursday AM
June 23, 2005

Room: State Street
Location: University Center

Session Chairs: Peter D. Moran, Michigan Technological University; Karl Hobart, Naval Research Laboratory

8:20 AM

S1, Buckling Time-Scale for Compressively-Strained Thin Films on Compliant Layers of Various Thickness: *R. L. Peterson*¹; K. D. Hobart²; F. J. Kub²; James C. Sturm¹; ¹Princeton University; ²US Naval Research Laboratory

8:40 AM Student

S2, Relaxed SiGe Donor Substrates Incorporating Engineered Hydrogen-Gettering Structures for Layer Transfer Applications: *David M. Isaacson*¹; Arthur J. Pitera¹; Eugene A. Fitzgerald¹; ¹Massachusetts Institute of Technology

9:00 AM Student

S3, Si Layer Transfer Using Plasma Hydrogenation: *Peng Chen*¹; S. S. Lau¹; Paul K. Chu²; Kimmo Henttinen³; Tommi Suni³; I. Suni³; N. David Theodore⁴; Terry L. Alford⁵; J. W. Mayer⁵; Lin Shao⁶; Michael Nastasi⁶; ¹University of California, San Diego; ²City University of Hong Kong; ³VTT Information Technologies; ⁴Freescale Semiconductor Inc.; ⁵Arizona State University; ⁶Los Alamos National Laboratory

9:20 AM

S4, Wafer Bonding with Partially-Cured Benzocyclobutene (BCB) for 3D Integration Applications: *Ravi J. Kumar*¹; F. Niklaus¹; J. Yu¹; J. J. McMahon¹; J.-Q. Lu¹; P. D. Persans¹; R. J. Gutmann¹; ¹Focus Center - New York, Rensselaer: Interconnections for Hyperintegration

9:40 AM

S5, Adhesive-Free Bond Between Sapphire and Garnet Single Crystals: *Huai-Chuan Lee*¹; Helmuth E. Meissner¹; Oliver Meissner¹; ¹Onyx Optics, Inc.,

10:00 AM Break

10:20 AM

S6, Dependence of Semiconducting Materials Properties on Exfoliation by Hydrogen Implantation: *Sumiko Lynn Hayashi*¹; Calin Miclaus¹; Geoge Malouf¹; Ginga Yoshizawa¹; David Bruno¹; Mark S. Goorsky¹; ¹University of California, Los Angeles

10:40 AM Student

S7, Low Resistance Ohmic GaAs/InP Bonded Heterojunctions for Lattice-Mismatched Multijunction Solar Cell Applications: *Katsuaki Tanabe*¹; Anna Fontcuberta I. Morral¹; Daniel J. Aiken²; Mark W. Wanlass³; Harry A. Atwater¹; ¹California Institute of Technology; ²Emcore Photovoltaics; ³National Renewable Energy Laboratory

11:00 AM

S8, Wafer Bonding of Nitride and II-VI Compounds for Optoelectronic Applications: *Akihiko Murai*¹; Carsten Kruse²; Lee McCarthy³; Katsuya Samonji¹; Umesh Mishra³; Steven P. DenBaars³; Stephan Figge²; Detlef Hommel²; ¹ERATO JST, UCSB Group; ²Bremen University; ³University of California Santa Barbara

11:20 AM Student

S9, Crystallographic and Morphological Effects of Ge/Si Transferred Epitaxial Templates on GaInP and GaAs Heterostructure Growth: *Melissa J. Griggs*¹; James M. Zahler¹; Anna Fontcuberta I. Morral¹; Harry A. Atwater¹; ¹California Institute of Technology

11:40 AM

S10, Integration of Multi-Spectral Nanocrystal Quantum Dots with Laser Assisted Forward Transfer Technique: *Michael Gerhold*¹; Jian Xu²; Justin Liou²; Y. Andrew Yang³; ¹Army Research Office; ²Pennsylvania State University; ³Nanomaterials & Nanofabrication Laboratories

Session T: Basic and Applied Optical Properties of Quantum Dots

Thursday AM
June 23, 2005

Room: Lobero
Location: University Center

Session Chairs: Ben Shanabrook, Naval Research Laboratory; James L. Merz, University of Notre Dame

8:20 AM

T1, Radiative Recombination of Charged Excitons and Multi-Excitons in CdSe Quantum Dots: *Alberto Franceschetti*¹; Claudia Troparevsky¹; ¹Oak Ridge National Laboratory

8:40 AM Student

T2, Neutral and Charged Multi-Exciton Complexes in Single InAs Quantum Dots Grown on InP(001): *Nicolas Chauvin*¹; Edern Tranvouez¹;

Georges Bremond¹; Gérard Guillot¹; Catherine Bru-Chevallier¹; Emmanuel Dupuy²; Philippe Regreny²; Michel Gendry²; ¹LPM; ²LEOM

9:00 AM

T3, Role of Crystal Field in the Formation of Dark and Bright Excitonic States in Nitride Quantum Dots: Subhasis Ghosh¹; *Anjana Bagga*¹; Pranab Kumar Chattopadhyay²; ¹Jawaharlal Nehru University; ²Maharshi Dayanand University

9:20 AM

T4, Dependence of 1.3 μm Quantum Dot Laser Performance on P-Doping and Electronic Structure: *Sabine Freisem*¹; Dennis G. Deppe¹; ¹University of Texas at Austin

9:40 AM

T5, High Performance of Superluminescent Diodes Utilizing Chirped Quantum Dots: *Il Ki Han*¹; Young Chae Yoo¹; Young Ju Park¹; Jin Dong Song¹; Won Jun Choi¹; Woon Jo Cho¹; Jung Il Lee¹; Joo In Lee²; Sam Kyu Noh²; Eun Kyu Kim³; ¹Korea Institute of Science and Technology; ²Korea Research Institute of Standards and Science; ³Hanyang University

10:00 AM Break

Session U: IR Quantum Dots and Wells

Thursday AM Room: Lobero
June 23, 2005 Location: University Center

Session Chairs: Diana Huffaker, University of New Mexico; Glenn S. Solomon, Stanford University

10:20 AM

U1, Self-Assembled Three-Dimensional Arrays of Quantum Dots for Infrared Detection: *Bogdan Lita*¹; Alexana Roshko¹; Todd E. Harvey¹; Marion Greene¹; Brittany Hyland¹; Kristine A. Bertness¹; John H. Lehman¹; ¹National Institute of Standards and Technology

10:40 AM Student

U2, Growth and Characterization of In(N)Sb/InAs Infrared Quantum Dots for Smart Sensor Applications: *Homan B. Yuen*¹; Seongsin M. Kim¹; Fariba Hatami¹; Kanji Yoh²; Akihiro Moto³; James S. Harris¹; ¹Stanford University; ²Hokkaido University; ³Innovation Core SEI, Inc.

11:00 AM Student

U3, High Density Nanometer-Scale InSb Dots Formation using Drop-lets Heteroepitaxial Growth by MOCVD: *Sergey Shusterman*¹; Ariel Sher¹; Yossi Paltiel¹; Yossi Rosenwaks²; ¹Soreq NRC; ²Tel-Aviv University

11:20 AM

U4, Band-Edge Characterization of Intermixed InGaAsP/InP and InGaAs/GaAs Quantum Wells: *Gordon B. Morrison*¹; James W. Raring¹; Chad S. Wang¹; Erik J. Skogen¹; Larry A. Coldren¹; ¹University of California, Santa Barbara

11:40 AM

U5, Growth of Ge/SiGe MQWs on Si Substrates Through Relaxed Ge-Rich SiGe Buffers for Long Wavelength Optical Devices: *Yu-Hsuan Kuo*¹;

Junxian Fu¹; Xiaojun Yu¹; Theodore I. Kamins²; Glenn S. Solomon¹; James S. Harris¹; ¹Stanford University; ²Hewlett-Packard Laboratories

Session V: Group III-Nitrides: Characterization, Defects, and Ordering

Thursday PM Room: Corwin East
June 23, 2005 Location: University Center

Session Chairs: Leonard J. Brillson, Ohio State University; Christian Wetzel, Future Chips Constellation

1:30 PM Student

V1, Analysis of Leakage Current Mechanisms in GaN and AlGaIn/GaN Schottky Diodes: *Hongtao Zhang*¹; Edward T. Yu¹; ¹University of California, San Diego

1:50 PM

V2, Time-Resolved Photoluminescence Measurement of Vertical Minority Carrier Transport in III-N Epilayers: *Gregory A. Garrett*¹; H. Shen¹; M. Wraback¹; ¹U.S. Army Research Laboratory

2:10 PM

V3, Experimental and Theoretical Investigation of Thermal Conductivity of Al_xGa_{1-x}N Thin Films: Weili Liu¹; *Alexander A. Balandin*¹; ¹University of California

2:30 PM

V4, Picosecond Acoustics in Bulk Nitride Films and Multilayer Structures: *Michael Wraback*¹; H. Shen¹; A. V. Sampath¹; C. J. Collins¹; ¹U.S. Army Research Laboratory

2:50 PM

V5, Electrical and Optical Characterization Studies of Al_xGa_{1-x}N Implanted with Silicon: *Mee-Yi Ryu*¹; Yung Kee Yeo²; Timothy W. Zens²; Michael A. Marciniak²; Robert L. Hengehold²; Todd D. Steiner³; ¹Kangwon National University; ²Air Force Institute of Technology; ³Air Force Office of Scientific Research

3:10 PM Break

3:30 PM Student

V6, Surface Oxide Relationships to Fermi Level Pinning in GaN: *Michael A. Garcia*¹; Scott D. Wolter¹; Tong-Ho Kim¹; April Brown¹; Maria Losurdo²; Giovanni Bruno²; ¹Duke University; ²IMIP-CNR

3:50 PM

V7, Giant Traps Observed on Top Surface of HVPE-Grown Freestanding GaN: *Zhaoqiang Fang*¹; David Look¹; Andre Krtischil²; Alois Krost²; ¹Wright State University; ²Otto-von-Guericke-University Magdeburg

4:10 PM

V8, Anisotropy in the Quantum Lifetime in AlGaIn/GaN Heterostructures: *William C. Mitchell*¹; W. D. Mitchell¹; S. Elhamri²; R. Berney²; ¹US Air Force; ²University of Dayton

4:30 PM

V9, Spontaneous Atomic Ordering and Band Gap Narrowing in Epitaxial Al_xGa_{1-x}N: *Min Gao*¹; Yong Lin¹; Shawn T. Bradley¹; Jeonghyun Hwang²; William J. Schaff²; Steven A. Ringel¹; Leonard J. Brillson¹; ¹Ohio State University; ²Cornell University

4:50 PM Student

V10, Compositional Dependence of Ordering in Al_xGa_{1-x}N Epitaxial Layers: *Adam T. Wise*¹; Nathan Newman¹; Subhash Mahajan¹; ¹Arizona State University

Session W: ZnO: Nanostructures

Thursday PM
June 23, 2005

Room: Corwin West
Location: University Center

Session Chairs: Yicheng Lu, Rutgers University; Zhong Lin Wang, Georgia Institute of Technology

1:30 PM Invited

W1, Novel Nanostructures of ZnO - Synthesis, Growth Mechanism, Properties and Applications: *Zhong Lin Wang*¹; ¹Georgia Institute of Technology

2:10 PM

W2, Catalyst Selection for ZnO Nanowire Growth Using an Integrated High-Throughput/Phase-Diagram Approach: *Albert Davydov*¹; Babak Nikoobakht¹; Norman A. Sanford¹; Daniel Josell¹; William J. Boettinger¹; Mark A. Vaudin¹; Lawrence H. Robins¹; Igor Levin¹; Carol Handwerker¹; ¹National Institute of Standards and Technology

2:30 PM Student

W3, Evolution of ZnO Nanostructures on Si by Vapor-Solid Mechanism in a Single Reactor: Structural and Optical Properties: Yoon-Bong Hahn¹; *Ahmad Umar*¹; Sang Hoon Kim¹; ¹Chonbuk National University

2:50 PM

W4, Studies on Growth, Morphology, and Property of ZnO-Based Nanostructures: *Debasish Banerjee*¹; Zhifeng Ren¹; ¹Boston College

3:10 PM Break

3:30 PM

W5, Step-By-Step Hierarchical Growth of Complex ZnO Nanocrystals: *Thomas L. Sounart*¹; Jun Liu¹; James A. Voigt¹; Julia Hsu¹; Bonnie McKenzie¹; ¹Sandia National Laboratories

3:50 PM

W6, Directed Assembly of ZnO Nanobridges on a Si Substrate Using a ZnO Seed Layer: *John F. Conley*¹; Yoshi Ono¹; Lisa H. Stecker¹; ¹Sharp Laboratories of America

4:10 PM

W7, Directed Assembly of ZnO Nanorods on Surfaces: *Julia W.P. Hsu*¹; Neil C. Simmons¹; Carolyn M. Matzke¹; Zhengrong R. Tian¹; James A. Voigt¹; Jun Liu¹; ¹Sandia National Laboratories

4:30 PM Student

W8, Structural and Optical Properties of ZnO Nanotips Grown on GaN: *Jian Zhong*¹; Gaurav Saraf¹; Hanhong Chen¹; Yicheng Lu¹; H. M. Ng²; T. Siegrist²; A. Parekh³; D. Lu³; E. A. Armour³; ¹Rutgers University; ²Lucent Technologies; ³Veeco Inc

4:50 PM Student

W9, The Lattice Mismatch Effects of ZnO Nanorods on Al₂O₃ Substrate: *Sun-Hong Park*¹; Soo-Young Seo¹; Seon-Hyo Kim¹; Sang-Wook Han²; ¹Pohang University of Science and Technology; ²Chon-Buk University

Session X: Flexible Thin-Film Electronics

Thursday PM
June 23, 2005

Room: Lotte Lehmann
Location: Music Hall

Session Chairs: William S. Wong, Palo Alto Research Center; Michael L. Chabiny, Palo Alto Research Center

1:30 PM Invited

X1, Flexible, Conformally Shaped, and Elastic Electronic Surfaces: *Sigurd Wagner*¹; ¹Princeton University

2:10 PM

X2, Carbon Nanotube Network Thin-Film Transistors for High-Performance Flexible Electronics: *Paul M. Campbell*¹; Eric S. Snow¹; Keith Perkins¹; Jamie Novak²; ¹Naval Research Laboratory; ²Applied Nanotech, Inc.

2:30 PM

X3, Thin-Film Gas Sensors on Heated Polyimide Membrane: *John Hatfield*¹; ¹University of Manchester

2:50 PM

X4, Electrical Properties of Biaxially-Oriented Si Thin Films on Flexible Polycrystalline Metal Tapes: *Woong Choi*¹; Quanxi Jia¹; Vlad Matias¹; Alp Findikoglu¹; ¹Los Alamos National Laboratory

3:10 PM Break

3:30 PM Student

X5, Enhanced Charge-Injection from NiO_x Electrode to Pentacene Channel in Flexible Thin-Film Transistors: *Jiyoul Lee*¹; Jeong-M. Choi¹; Seongil Im¹; ¹Yonsei University

3:50 PM

X6, Rigid Device Islands on Elastomeric Substrates: *Stephanie P. Lacour*¹; Sigurd Wagner¹; ¹Princeton University

4:10 PM

X7, Low-Temperature a-Si:H Thin-Film Transistor Arrays Fabricated by Digital Lithography: *William S. Wong*¹; Rene Lujan¹; Juergen Daniel¹; Robert A. Street¹; ¹Palo Alto Research Center

4:30 PM Student

X8, Dimensionally Stable Processing of a-Si TFTs on Polymer Foils:

*Alex Kattamis*¹; I.-Chun Cheng¹; Ke Long¹; James C. Sturm¹; Sigurd Wagner¹; ¹Princeton University

4:50 PM

X9, Low Coherence Optical Interferometry for Flexible Electronic

Device Metrology: *Wojtek J. Walecki*¹; Alexander Pravdivstev¹; Mihail Mihaylov¹; Manuel Santos¹; Kevin Lai¹; Ann Koo¹; ¹FSM

Session Y: Nanotubes and Nanowires

Thursday PM
June 23, 2005

Room: Multicultural Theater
Location: Multicultural Center

Session Chair: Ray Tsui, Motorola Laboratories

1:30 PM Student

Y1, Air-Stable Carbon Nanotube Field-Effect Transistors with Top-Gate Structures on SiNX Passivation Films Formed by Catalytic Chemical Vapor Deposition: *Daisuke Kaminishi*¹; Yasuhide Ohno¹; Kenzo Maehashi¹; Koichi Inoue¹; Kazuhiko Matsumoto¹; Yasuhiro Seri²; Atsushi Masuda²; Hideki Matsumura²; Toshikazu Niki³; ¹Osaka University; ²Japan Advanced Institute of Science and Technology; ³Ishikawa Seisakusho, Ltd.

1:50 PM Student

Y2, Electrical Transport Modeling of Carbon Nanotube Field Effect Transistors: *Tongsheng Xia*¹; Leonard F. Register¹; Sanjay K. Banerjee¹; ¹University of Texas-Austin

2:10 PM Student

Y3, Staircase Characteristics of Oxygen-Free Carbon Nanotube Field Effect Transistors Desorbed by Electrical Heating: *Takafumi Kamimura*¹; Masatoshi Maeda²; Chan Kyeong Hyon³; Kazuhiko Matsumoto¹; ¹Osaka University; ²University of Tsukuba; ³CREST/ Japan Science and Technology Agency

2:30 PM

Y4, Bi-Functional Carbon Nanotubes by Sidewall Protection Using Aligned Carbon Nanotube Membranes: *Bruce J. Hinds*¹; Nitin Chopra¹; Bing Hu¹; ¹University of Kentucky

2:50 PM

Y5, Calculations on Co-Solvents of Single-Wall Carbon Nanotubes: *Francisco Torrens*¹; ¹Universitat de Valencia

3:10 PM Break

3:30 PM Student

Y6, Biologically Directed Synthesis for Gold Nanowires: *Chung-Yi Chiang*¹; Yu Huang¹; Soo-Kwan Lee¹; Yan Gao²; Evelyn Hu²; Angela M. Belcher¹; ¹Massachusetts Institute of Technology; ²University of California, Santa Barbara

3:50 PM

Y7, Electrical Characterization of Bio-Templated Nanowires: *Yan Gao*¹; Jing C. Zhou²; Chung-Yi Chiang³; Yu Huang³; Ki Tae Nam³; Angela Belcher³;

Bruce Dunn²; Evelyn Hu¹; ¹University of California, Santa Barbara; ²University of California, Los Angeles; ³Massachusetts Institute of Technology

4:10 PM

Y8, Room-Temperature Ferromagnetic Ordering in (Mn, Fe) Doped ZnS Nanobelts:

W. Y. Shim¹; J. Sung²; T. Kang²; B. Kim²; M. H. Jung³; W. Y. Lee¹; ¹Yonsei University; ²KAIST; ³Korea Basic Science Institute

4:30 PM Student

Y9, Selective Growth, Diameter Control, and Mechanistic Study of

Copper Oxide Nanowires Grown from Exposed Edge of Al₂O₃/Cu/Al₂O₃ Thin Film Multilayer Structure: *Nitin Chopra*¹; Bing Hu¹; Bruce Jackson Hinds¹; ¹University of Kentucky

4:50 PM Student

Y10, Photoconductive NiSi Nanowires Formed by Metal – Induced

Growth: *Joondong Kim*¹; Dongho Lee¹; Wayne A. Anderson¹; ¹University at Buffalo

Session Z: Chemical and Biological Sensors: Materials, Interfaces, and Integration

Thursday PM
June 23, 2005

Room: SB Harbor
Location: University Center

Session Chairs: Laura Rea, Air Force Research Laboratory; Lloyd Whitman, Naval Research Laboratory

1:30 PM Student

Z1, Composition and Contextual Influence of Peptide Specificity for Inorganic Material Surfaces: *Eric Krauland*¹; Beau Peelle¹; K. Dane Wittrup¹; Angela M. Belcher¹; ¹Massachusetts Institute of Technology

1:50 PM

Z2, New Biologically Inspired Low-Temperature Nanofabrication of

Metal Oxide Semiconductors for Photovoltaic and Other Applications: *Daniel E. Morse*¹; Kristian M. Roth¹; David Kisailus¹; ¹Institute for Collaborative Biotechnologies, California NanoSystems Institute and Materials Research Laboratory

2:10 PM

Z3, Chemical Sensing Based on Reversible Desthiobiotin Gated Ionic

Transport through Aligned Carbon Nanotube Membranes: *Bruce J. Hinds*¹; Pramod Nednoor¹; Nitin Chopra¹; Leonidas Bachas¹; ¹University of Kentucky

2:30 PM

Z4, Controlled Assembly of Molecular-Scale, Electrically Conductive

and Highly Aligned Carbon Nanotube Electrodes: *Nikolai A. Kouklin*¹; W. E. Kim²; A. D. Lazarek²; Jimmy Xu²; ¹University of Wisconsin Milwaukee; ²Brown University

2:50 PM

Z5, The Role of Interface Material on the Sensitivity of Metal/Carbon

Nanotube/Metal Sensors to Hydrogen and Volatile Gases: *Frank E. Jones*¹; Alec Talin¹; Paul M. Dentinger¹; Francois Leonard¹; Robert J. Bastasz¹; ¹Sandia National Laboratories

3:10 PM Break

3:30 PM Student

Z6, Electrowetting Based Fluid Flow: Impact of Surface Functionalization with Self-Assembled Monolayers (SAMs): *Suvid Nadkarni*¹; Ananth Dodabalapur¹; ¹University of Texas at Austin

3:50 PM Student

Z7, Chemically-Gated AlGaIn/GaN Heterojunction Field Effect Transistors for Liquid Sensing: *Junghui Song*¹; Hyunchul Jung¹; Jeffrey S. Flynn²; George R. Brandes²; Wu Lu¹; ¹Ohio State University; ²Cree Inc

4:10 PM

Z8, Biosensors Based on InAs/AlGaSb and AlGaIn/GaN Devices: *K. M. McCoy*¹; J. C. Sullivan¹; J. C. Culbertson¹; E. S. Snow¹; Stephen John Pearton; Lloyd Whitman; ¹Naval Research Laboratory

4:30 PM Student

Z9, Conduction-Based Gas Sensor Using Redox Molecules as an Active Sensing Component: *Kangho Lee*¹; Wendy Fan²; Meyya Meyyappan²; David B. Janes¹; ¹Purdue University; ²NASA Ames Research Center

4:50 PM

Z10, Late News

Session AA:

Lattice-Engineered Materials and Devices

Thursday PM
June 23, 2005

Room: State Street
Location: University Center

Session Chairs: Ralph L. Dawson, University of New Mexico;
Steven A. Ringel, Ohio State University

1:30 PM Student

AA1, Effect of AlSb Metamorphic Buffer Layer Thickness on the Performance of InAs-Channel HEMT Structures: *Atif M. Noori*¹; Randy Sandhu²; Sumiko Hayashi¹; Erik Meserole¹; Mike Lange²; Roger Tsai²; Augusto Gutierrez-Aitken²; Mark Goorsky¹; ¹University of California, Los Angeles; ²Northrop Grumman Space Technology

1:50 PM Student

AA2, Strong Room Temperature Photoluminescence from Metamorphic InGaAs Quantum Wells: Issues Beyond Dislocation Density: *Henry Choy*¹; Clifton Fonstad¹; ¹Massachusetts Institute of Technology

2:10 PM Student

AA3, The Effect of Dislocation Interactions on Strain Relaxation in GaAsSb/GaAs Heteroepitaxy: *Benny Perez Rodriguez*¹; Joanna Mirecki Millunchick¹; ¹University of Michigan

2:30 PM Student

AA4, Metamorphic InP/GaAsSb/InP HBTs on GaAs Substrates by MOCVD: *Min Chen*¹; Wei Zhou¹; Jia Zhu¹; Yong Cai¹; Wilson Tang¹; Kevin J. Chen¹; Kei May Lau¹; ¹Hong Kong University of Science and Technology

2:50 PM Student

AA5, Defect Behavior in Metamorphic Buffer Layers on Lattice Constants Near InP Grown by Metal Organic Chemical Vapor Deposition (MOCVD) on GaAs: *Nate Quitarano*¹; Eugene Fitzgerald¹; ¹Massachusetts Institute of Technology

3:10 PM Break

3:30 PM Student

AA6, Effects of High-Temperature Rapid Thermal Annealing on Structural, Optical, and Electrical Properties of Metamorphic In_{0.52}Al_{0.48}As/In_{0.53}Ga_{0.47}As Heterostructures Grown on GaAs Substrates: *Soo-Ghang Ihn*¹; Seong-June Jo¹; Tae-Woo Kim¹; Kyung-Hwan Oh¹; Jong-In Song¹; ¹Gwangju Institute of Science and Technology

3:50 PM Student

AA7, Metamorphic Growth of Wavelength-Extended InGaAs on InP with Cycling In-Situ Annealed Step-Graded InAlAs and InGaAs Buffers: *Junxian Fu*¹; Xiaojun Yu¹; Yu-Hsuan Kuo¹; James S. Harris¹; ¹Stanford University

4:10 PM

AA8, Ultra-Thin Low Threading Dislocation Density In_{0.86}Al_{0.14}As Virtual Substrates for the Development of 6.00Å In_{0.86}Al_{0.14}As/In_{0.86}Ga_{0.14}As HBT: *Rajinder Sandhu*¹; Abdullah Cavus¹; Cedric Monier¹; Atif Noori²; Sumiko Hayashi²; Mark Goorsky²; Augusto Gutierrez-Aitken¹; ¹Northrup Grumman Space Technology; ²University of California, Los Angeles

4:30 PM Student

AA9, Metalorganic Vapor Phase Epitaxy of High Resistivity Lattice-Mismatched InAs_xP_{1-x} (x=0.20 to 0.75) on InP Buffer Layer: *Steven Sontung Bui*¹; Henry P. Lee¹; ¹University of California, Irvine

4:50 PM Student

AA10, The Effects of As₂ Versus As₄ on Step-Graded InAs_xP_{1-x} Mixed-Anion Alloys Grown on InP Substrates with Solid Source MBE: *Wanming Zhang*¹; Changyun Yi¹; April Brown¹; ¹Duke University

Session BB:

Wide Bandgap Wells, Wires, and Dots

Thursday PM
June 23, 2005

Room: Lobero
Location: University Center

Session Chairs: Glenn S. Solomon, Stanford University; Mark S. Miller, University of Utah

1:30 PM

BB1, Synthesis and Biological Applications of GaN Nanoparticles: *Jifa Qi*¹; Saeeda Jaffar¹; Jennifer Hsieh¹; Angela M. Belcher¹; Yan Gao²; Evelyn Hu²; ¹Massachusetts Institute of Technology; ²University of California

1:50 PM

BB2, Catalyst-Free Growth of GaN and AlGaIn Nanowires: *Kris A. Bertness*¹; N. A. Sanford¹; J. M. Barker¹; J. B. Schlager¹; A. Roshko¹; A. V. Davydov¹; I. Levin¹; ¹National Institute of Standards and Technology

2:10 PM

BB3, Spectroscopic Study of GaN and AlGa_N Nanowires Grown by MBE: *Lawrence H. Robins*¹; John B. Schlager¹; Norman A. Sanford¹; Kristine A. Bertness¹; Joy Barker¹; ¹National Institute of Standards and Technology

2:30 PM

BB4, Formation of Ni Nanodots and Controlled Growth of GaN Nanowires by Pulsed MOCVD: *Mark Holtz*¹; D. Aurongzeb¹; G. Kipshidze¹; B. Yavich¹; A. Chandolu¹; V. Kuryatkov¹; I. Ahmad¹; H. Temkin¹; ¹Texas Tech University

2:50 PM Student

BB5, GaN/AlN Multiple Quantum Wells Grown on GaN-AlN Waveguide Structures by Metalorganic Vapor Phase Epitaxy: *Chaiyasit Kumtornkittikul*¹; Masakazu Sugiyama²; Yoshiaki Nakano¹; ¹RCAST, University of Tokyo and JST-SORST; ²University of Tokyo

3:10 PM Break

3:30 PM

BB6, Structural and Optical Characterization of CdSe/CdS Colloidal Quantum Dots Spin-Cast on GaAs Substrates for Application to Infrared Photodetectors: *Adrienne D. Stiff-Roberts*¹; Wanming Zhang¹; Hongying Peng¹; Henry Everitt¹; Jian Xu²; ¹Duke University; ²Pennsylvania State University

3:50 PM Student

BB7, Electrical and Structural Characterization of Self-Assembled ZnO Nanoparticles in Diblock Copolymers on Si Substrates: *Hasina Afroz Ali*¹; Agis Iliadis¹; Luz Martinez-Miranda¹; Unchul Lee²; ¹University of Maryland, College Park; ²Army Research Laboratory

4:10 PM Student

BB8, Electrical Properties of ZnO Nano-Particles Embedded in Polyimide: Eun Kyu Kim¹; *JaeHoon Kim*¹; Hyung Gu Noh¹; Young Ho Kim¹; ¹Hanyang University

4:30 PM Student

BB9, Excitons and Optical Phonons in Wurtzite ZnO Quantum Dots: Theory and Experiment: *Vladimir A. Fonoberov*¹; Alexander A. Balandin¹; ¹University of California

Session CC: Bulk GaN

Friday AM
June 24, 2005

Room: Corwin East
Location: University Center

Session Chairs: Paul T. Fini, University of California, Santa Barbara; Zlatko Sitar, North Carolina State University

8:20 AM Student

CC1, Characterization of GaN Films Grown on Free-Standing GaN Seeds by Ammonothermal Growth: *Tadao Hashimoto*¹; Kenji Fujito²; Feng Wu²; Benjamin A. Haskell²; Takeyoshi Onuma³; Shigefusa F. Chichibu³; James S. Speck²; Shuji Nakamura²; ¹ERATO, JST, University of California, Santa Barbara; ²University of California; ³University of Tsukuba

8:40 AM

CC2, Crystallization of Free Standing Bulk GaN by HVPE: *Bogdan Pastuszka*¹; ¹Instytut Wysokich Cisnien PAN

9:00 AM

CC3, Optimization of the Ammonothermal Technique for the Production of Large Low Defect GaN Crystals: *Kelly Rakes*¹; Buguo Wang²; Bunmi Adekore³; Shrinivas Pendurti⁴; Michael Callahan¹; Lioniel Bouthilllette¹; David Bliss¹; Sheng-Qi Wang²; Zlatko Sitar²; ¹Air Force Research Laboratory; ²Solid State Scientific Corporation; ³North Carolina State University; ⁴Florida International University

9:20 AM

CC4, "Homoepitaxial" Growth of Bulk GaN by HVPE on Near Dislocation Free Pressure Grown GaN Substrates: *Boleslaw Lucznik*¹; Bogdan Pastuszka¹; ¹Instytut Wysokich Cisnien PAN

9:40 AM

CC5, Growth of GaN on Patterned with SiN Mask GaN/Sapphire Substrates by High Pressure Solution Method: *Michal Bockowski*¹; ¹Institute of High Pressure Physics PAS

10:00 AM Break

Session DD: Properties of Nitrides for Electronics

Friday AM
June 24, 2005

Room: Corwin East
Location: University Center

Session Chairs: James Speck, University of California; Gregor Koblmüller, University of California, Santa Barbara

10:20 AM Student

DD1, Impact of Threading Dislocation Density on Forward Biased I-V-T Characteristics of n-Type Ni/GaN Schottky Diodes: *Aaron R. Arehart*¹; B. Moran²; J. S. Speck²; U. K. Mishra²; S. P. DenBaars²; S. A. Ringel¹; ¹Ohio State University; ²University of California

10:40 AM

DD2, Threshold Voltage Control of AlGa_N/GaN HEMTs by CF₄ Plasma Treatment: *Yong Cai*¹; Yu Gang Zhou¹; Kevin Jing Chen¹; Kei May Lau¹; ¹Hong Kong University of Science and Technology

11:00 AM

DD3, Transient Self-Heating Effects in AlGa_N/GaN HEMTs: *Jan Kuzmik*¹; Sergey Bychikhin¹; Martin Neuberger²; A. Dadgar³; Matej Blahol¹; A. Krost³; Erhard Kohn²; Dionyz Pogany¹; ¹Technical University Vienna; ²University of Ulm; ³Otto-von-Guericke University Magdeburg

11:20 AM

DD4, Micro-Raman Studies of Thermal Stress Effects in GaN Heteroepitaxial Layers and Nitride-Based HEMT Structures: *Jihyun Kim*¹; J. A. Freitas²; E. R. Glaser²; D. S. Katzer²; J. Mittereder²; S. Guo³; B. Albert³; B. Peres³; I. Eliashevich³; ¹University of Florida; ²Naval Research Laboratory; ³Emcore Corporation

11:40 AM

DD5, High Thermal Stability W_2B Ohmic Contacts to GaN: *Rohit Khanna*¹; C. J. Kao¹; I. Kravchenko¹; F. Ren¹; G. C. Chi¹; S. J. Pearton¹; A. Dabiran²; A. Osinsky²; ¹University of Florida; ²SVT Associates

Session EE: ZnO: Thin-Film and Bulk Growth

Friday AM
June 24, 2005

Room: Corwin West
Location: University Center

Session Chairs: David P. Norton, University of Florida; Thomas Myers, West Virginia University

8:20 AM

EE1, MBE Growth of High-Quality ZnO Layers on Sapphire: Abdel-Hamid El-Shaer¹; Augustine Che Mofor¹; Andrey Bakin¹; Marc Kreye¹; *Andreas Waag*¹; Frank Bertram²; Jürgen Christen²; Johannis Stoimenos³; ¹Technical University Braunschweig; ²Otto-von-Guericke-University Magdeburg; ³Aristotele University Thessaloniki

8:40 AM Student

EE2, ZnO Growth on Si with Low-Temperature ZnO Buffer Layers by ECR-Assisted MBE: *Faxian Xiu*¹; Zheng Yang¹; Dengtao Zhao¹; Jianlin Liu¹; Khan K. Alim¹; Alexander A. Balandin¹; Mikhail Itkis¹; Robert Haddon¹; ¹University of California

9:00 AM

EE3, High Quality MBE-Grown ZnCdO Layers for Visible Light Emitters: *Jianwei Dong*¹; Andrei Osinsky¹; Junqing Xie¹; Brian Hertog¹; Amir Dabiran¹; Peter Chow¹; Alexander Mintairov²; James Merz²; David Look³; Olena Lopatiuk⁴; Leonid Chernyak⁴; ¹SVT Associates, Inc.; ²University of Notre Dame; ³Wright State University; ⁴University of Central Florida

9:20 AM

EE4, Characteristics of ZnO Epilayers Grown by Plasma-Assisted Molecular Beam Epitaxy on GaN/Sapphire (0001): *C. J. Pan*¹; W. M. Wang¹; C. W. Tu¹; J. J. Song¹; G. Cantwell²; G. C. Chi³; ¹University of California, San Diego; ²ZN Technology, Inc.; ³National Central University

9:40 AM Student

EE5, Growth of Atomically-Flat ZnO and Related Alloy Films by Helicon-Wave-Excited-Plasma Sputtering Epitaxy Method: *Naoyuki Shibata*¹; Takuya Ohmori¹; Takahiro Koyama¹; Takeyoshi Onuma¹; Shigefusa F. Chichibu¹; ¹University of Tsukuba

10:00 AM Break

10:20 AM

EE6, Reactivity of ZnO: Impact of Polarity and Nanostructure: *Maria Losurdo*¹; Maria Giangregorio²; Pio Capezzuto¹; Giovanni Bruno¹; Graziella Malandrino³; Ignazio Fragala³; ¹IMIP-CNR; ²INSTM; ³University of Catania

10:40 AM

EE7, Metalorganic Chemical Vapor Deposition and Characterization of ZnO materials: *Shangzhu Sun*¹; Tompa Gary¹; Brent Hoerman¹; Dave

Look²; Bruce Claflin²; Catherine Rice¹; Puneet Masaun¹; ¹Structured Materials Industries, Inc.; ²Wright State University

11:00 AM

EE8, Growth and Characterization of Hydrothermal ZnO and ZnMgO Bulk Crystals: *Michael Callahan*¹; Buguo Wang²; Lioniel Bouthilllette¹; Erik Grant¹; Sheng-Qi Wang²; Kelly Rakes¹; Michael Suscavage¹; David Bliss¹; ¹Air Force Research Laboratory; ²Solid State Scientific Corporation

11:20 AM

EE9, Late News

Session FF: Contacts to Semiconductor Structures

Friday AM
June 24, 2005

Room: Lotte Lehmann
Location: Music Hall

Session Chairs: Suzanne E. Mohny, Pennsylvania State University; Jerry M. Woodall, Purdue University

8:20 AM Student

FF1, Annealed Ge/Ag/Ni Ohmic Contact on InAlAs/InGaAs HEMT for High Temperature Applications Using Silicon Nitride Passivation Layers: *Weifeng Zhao*¹; Seiyon Kim¹; Fitihi Mohammed¹; Liang Wang¹; Ilesanmi Adesida¹; ¹University of Illinois

8:40 AM

FF2, ITO-Based Ohmic Contacts on n- and p-Type ZnO Layers: Sang-Ho Kim¹; Seong-Wook Jeong¹; Jeong-Tae Maeng¹; Dae-Kue Hwang¹; Seong-Ju Park¹; *Tae-Yeon Seong*¹; ¹Gwangju Institute of Science and Technology

9:00 AM Student

FF3, Cr/Pt Ohmic Contacts to $B_{12}As_2$: *Sammy H. Wang*¹; Eric M. Lysczek¹; Bangzhi Liu¹; Suzanne E. Mohny¹; Rajamani Nagarajan²; Zhou Xu²; J. H. Edgar²; ¹Pennsylvania State University; ²Kansas State University

9:20 AM Student

FF4, Contacts to Nanostructured Carbon Films: *Pranita B. Kulkarni*¹; Lisa M. Porter¹; Chuanbing Tang¹; Tomek Kowalewski¹; Krzysztof Matyjaszewski¹; ¹Carnegie Mellon University

9:40 AM Student

FF5, Schottky Barrier Formation at Non-Polar Au/GaN Epilayer Interfaces: *Dennis E. Walker, Jr.*¹; Leonard J. Brillson¹; William J. Schaff²; ¹Ohio State University; ²Cornell University

10:00 AM Break

10:20 AM Student

FF6, Fabrication and Characterization of Nanoscale Devices from Gallium Nitride Nanowires Utilizing Focused Ion Beam Induced Metal Deposition Techniques: *Abhishek Motayed*¹; Albert V. Davydov²; Mark Vaudin²; John Melngailis¹; S. N. Mohammad³; ¹University of Maryland; ²National Institute of Standards and Technology; ³Howard University

10:40 AM Student

FF7, Focused Ion Beam Induced Deposition of Platinum Ohmic Contacts on GaN Nanowires: *Chang-Yong Nam*¹; John E. Fischer¹; ¹University of Pennsylvania

11:00 AM Student

FF8, Low Resistance and High Transparency ZnO Contacts to p-GaN for High Performance GaN-Based LEDs: *Sung-Pyo Jung*¹; Jae-Hong Lim²; Dae-Kue Hwang²; Ja-Yeon Kim²; Eun-Jeong Yang²; Denise Ullery¹; Chien-Hung Lin¹; Seong-Ju Park²; Henry P. Lee¹; ¹University of California, Irvine; ²Gwangju Institute of Science and Technology

11:20 AM Student

FF9, Holographically Patterned Transparent p-Type GaN Ohmic Contacts for High-Brightness LEDs: *Dong-Seok Leem*¹; J. Cho²; J. S. Kwak²; Tae-Yeon Seong¹; ¹Gwangju Institute of Science and Technology; ²Samsung Advanced Institute of Technology

11:40 AM

FF10, Late News

Session GG: Silicon Carbide: Growth, Processing, and Characterization

Friday AM
June 24, 2005

Room: Multicultural Theater
Location: Multicultural Center

Session Chairs: Robert Stahlbush, Naval Research Laboratory;
Robert S. Okojie, NASA Glenn Research Center

8:20 AM

GG1, Characterization of High-Purity 4H-SiC Substrates Using Microwave Photoconductivity Decay: *Ravi J. Kumar*¹; J. R. Jenny²; D. P. Malta²; J. M. Borrego¹; H. McD. Hobgood²; R. J. Gutmann¹; ¹Rensselaer Polytechnic Institute; ²Cree Inc.

8:40 AM Student

GG2, Relationship between Room Temperature IR Photoluminescence and Resistivity in Semi-Insulating 6H SiC: *Sashi K. Chanda*¹; Yaroslav Koshka¹; Murugesu Yoganathan²; ¹Mississippi State University; ²Wide Band Gap Materials Group, II-VI, Inc.

9:00 AM Student

GG3, Effect of High Temperature Processing on the Creation of Boron-Related Deep Levels in 4H-SiC: *Hrishikesh Das*¹; Yaroslav Koshka¹; Michael S. Mazzola¹; Swapna Geetha Sunkari¹; Jeffery Wyatt¹; ¹Mississippi State University

9:20 AM Student

GG4, Material and Electrical Properties of HfO₂ Thin Films on 4H-SiC: *Carey M. Tanner*¹; Jongwoo Choi¹; Jane P. Chang¹; ¹University of California, Los Angeles

9:40 AM

GG5, Barrier Height Inhomogeneities in Schottky Diodes Fabricated on Differently Oriented 4H Silicon Carbide Wafers: *Xianyun Ma*¹;

Priyamvada Sadagopan²; Tangali Sudarshan²; ¹MaxMile Technologies, LLC; ²University of South Carolina

10:00 AM Break

10:20 AM

GG6, A Study of Morphological Evolution in Heteroepitaxial 3C-SiC Growth by Chemical Vapor Deposition: *Jungheum Yun*¹; Tetsuo Takahashi¹; Takeshi Mitani¹; Yuuki Ishida¹; Hajime Okumura¹; ¹National Institute of Advanced Industrial Science and Technology

10:40 AM Student

GG7, Effects of Variations of Processing Parameters in Deep-Level Centers in 4H and 6H-Silicon Carbide Metal Oxide Semiconductor Field-Effect Transistors: *Morgen S. Dautrich*¹; David J. Meyer¹; Patrick M. Lenahan¹; Aviars J. Leles²; ¹Pennsylvania State University; ²Army Research Laboratory

11:00 AM

GG8, Extraction of Interface States in 4H- and 6H-SiC MOSFETs Using Subthreshold Characteristics at 25 and 150°C: *Yanqing Deng*¹; Wei Wang¹; Qizhi Fang¹; Mahalingam Koushik¹; T. Paul Chow¹; ¹Rensselaer Polytechnic Institute

11:20 AM Student

GG9, Characterization of Ti Schottky Diodes on Epi-Regrown 4H-SiC: *Lin Zhu*¹; Canhua Li¹; T. Paul Chow¹; I. Bhat¹; ¹Rensselaer Polytechnic Institute

11:40 AM

GG10, Late News

Session HH: Molecular Electronics

Friday AM
June 24, 2005

Room: SB Harbor
Location: University Center

Session Chairs: David B. Janes, Purdue University; Mark C. Hersam, Northwestern University

8:20 AM Invited

HH1, Structural Characterization of Molecular Devices: Amy Walker¹; ¹Washington University

9:00 AM

HH2, Bias-Sweep Effects in the Electrical Characteristics of Hg-Alkanethiol/Oligo(Phenylene-Ethynylene)-Au Heterobilayer Molecular Junctions: *Richard A. Kiehl*¹; James A. Skarie¹; Thomas R. Hoye¹; John D. Le¹; Panglijen Candra¹; Rebecca Hoye²; ¹University of Minnesota; ²Macalester College

9:20 AM Student

HH3, Measurement of Single Molecule Conductance with Nanoscale Break Junctions: *Ajit Kumar Mahapatro*¹; Kyung Jae Jeong¹; Subhasis Ghosh²; Sugata Bhattacharya¹; Gil Lee¹; David B. Janes¹; ¹Purdue University; ²Jawaharlal Nehru University

9:40 AM Student

HH4, The Kondo Effect and Inelastic Electron Tunneling Spectroscopy in Transition Metal Based Single-Molecule Transistors: *Lam Yu*¹; Zachary Keane¹; Jacob Ciszek¹; Long Cheng¹; Michael Stewart¹; James Tour¹; Douglas Natelson¹; ¹Rice University

10:00 AM Break

10:20 AM

HH5, Bistability, Switching, and Error Tolerance of Molecular Quantum-Dot Cellular Automata: *Yuhui Lu*¹; Craig S. Lent¹; ¹University of Notre Dame

10:40 AM Student

HH6, Metal-Molecule-Silicon Device Structures: *Adina Scott*¹; David B. Janes¹; ¹Purdue University

11:00 AM Student

HH7, BEEM Studies of Au/Molecule/n-GaAs Diodes: *Wenjie Li*¹; Karen Kavanagh¹; Carolyn Matzke²; Alec Talin²; François Léonard²; Sergey Faleev²; Julia Hsu²; ¹Simon Fraser University; ²Sandia National Laboratories

11:20 AM Student

HH8, Minimization of Interface Oxide in Alkanethiol/GaAs Self-Assembled Monolayers: Richard A. Kiehl¹; *Panglijen Candra*¹; John D. Le¹; James A. Skarie¹; ¹University of Minnesota

11:40 AM Student

HH9, Shadow Evaporation Technique for Top Contacts of Molecular Devices: *Qingling Hang*¹; Patrick D. Carpenter¹; Adina Scott¹; David B. Janes¹; ¹Purdue University

12:00 PM

HH10, Late News

*Terashima*¹; Song-Bek Che¹; Yoshihiro Ishitani¹; Akihiko Yoshikawa¹; ¹Chiba University

9:20 AM Student

II4, Substrate Polarity Effects on the MOCVD Growth of InN: *Abhishek Jain*¹; Joan M. Redwing¹; Morad Abouzaid²; Pierre Ruterana²; Brenda VanMil³; Thomas H. Myers³; Protima Singh; ¹Pennsylvania State University; ²SIFCOM; ³West Virginia University

9:40 AM

II5, Optical Properties of InN Grown on 6H-SiC by Plasma Assisted Molecular Beam Epitaxy: *Maria Losurdo*¹; Maria M. Giangregorio²; Pio Capezzuto¹; Giovanni Bruno¹; Tong-Ho Kim³; Soojeong Choi³; Pae Wu³; Michael Morse³; April Brown³; Akihiro Moto⁴; ¹IMIP-CNR; ²INSTM-Bari; ³Duke University; ⁴Innovation Core SEI, Inc

10:00 AM Break

10:20 AM

II6, Structural Properties of Heteroepitaxial InN Grown on GaN(0001) by Molecular-Beam Epitaxy: *Maohai Xie*¹; Yongge Cao¹; Shihong Xu¹; Y. F. Chan²; Ning Wang²; Wei Lu³; Xianqi Dai¹; Ying Liu¹; Huasheng Wu¹; S. Y. Tong⁴; ¹University of Hong Kong; ²Hong Kong University of Science and Technology; ³Chinese Academy of Sciences; ⁴City University of Hong Kong

10:40 AM

II7, Carrier Dynamics Study and Multiphoton Excitation of Strained InN/GaN Multi-Quantum-Well Systems: *Duksu Kim*¹; Sangsu Hong¹; Kyu-Han Lee¹; ¹Samsung Electro-Mechanics

11:00 AM

II8, Quantum-Structure Dependent Excitonic Carrier Dynamics of In_xGa_{1-x}N/GaN Multi-Quantum-Wells: *Sangsu Hong*¹; Yong Seok Kim¹; Je Won Kim¹; Gyu Han Lee¹; Duksu Kim¹; Young Joon Yoon¹; Taiha Joo²; ¹Samsung Electro-Mechanics Co., Ltd.; ²Pohang University of Science and Technology

11:20 AM Student

II9, Growth of In-Rich InGaN/GaN Multiple Quantum Wells and Their Optical Properties: *Soon-Yong Kwon*¹; Sung-Il Baik¹; Hee Jin Kim¹; Young-Woon Kim¹; Jung-Won Yoon²; Hyeonsik M. Cheong²; Yoon-Soo Park¹; Euijoon Yoon¹; ¹Seoul National University; ²Sogang University

11:40 AM Student

II10, Growth Rate Dependence and Stability of Phase Separated Microstructures in InGaN: *Manu Rao*¹; Nathan Newman¹; Subhash Mahajan¹; ¹Arizona State University

Session II: InN and In-Rich Nitrides

Friday AM Room: State Street
June 24, 2005 Location: University Center

Session Chairs: William Schaff, Cornell University; Joan M. Redwing, Pennsylvania State University; Wladek Walukiewicz, Lawrence Berkeley Laboratory

8:20 AM

II1, Growth and Structural Characterization of InN-Based Quantum Well Structures Grown by RF-MBE on (0001) Sapphire: *Tsutomu Araki*¹; Masahito Kurouchi¹; Hiroyuki Naoi¹; Yasushi Nanishi¹; ¹Ritsumeikan University

8:40 AM Student

II2, Room Temperature Photoluminescence Emission from InN/In_{0.75}Ga_{0.25}N Multiple Quantum Wells: *Tatsuo Ohashi*¹; Shunsuke Ishizawa¹; Akihiko Kikuchi¹; Katsumi Kishino¹; ¹Sophia University

9:00 AM Student

II3, Structural and Optical Properties in the Whole Composition Range of AllIn Ternary Alloys Grown by RF-Molecular Beam Epitaxy: *Wataru*

Session JJ: Epitaxial Quantum Dot Growth and Properties

Friday AM Room: Lobero
June 24, 2005 Location: University Center

Session Chairs: James L. Merz, University of Notre Dame; Ben Shanabrook, Naval Research Laboratory

8:20 AM Student

JJ1, Control of Lateral Placement of InAs/GaAs Quantum Dots via Surface Patterning: *Weifeng Ye*¹; Xiaojun Weng¹; Matt Reason¹; Rachel Goldman¹; Fumiya Watanabe²; David Cahill²; ¹University of Michigan; ²University of Illinois

8:40 AM

JJ2, Fabrication of Site-Controlled Quantum Dots on GaAs(100) and (111)A: *Jong Su Kim*¹; Mitsuo Kawabe¹; Nobuyuki Koguchi¹; ¹National Institute for Materials Science

9:00 AM

JJ3, Growth of Multiple Stacked InP/In_{0.5}Al_{0.3}Ga_{0.2}P Quantum Dots by Metalorganic Chemical Vapor Deposition: *Xue-Bing Zhang*¹; Jae-Hyun Ryou¹; Russell Dupuis¹; Li He²; Robert Hull²; Gabriel Walter³; Nick Holonyak³; ¹Georgia Institute of Technology; ²University of Virginia; ³University of Illinois at Urbana-Champaign

9:20 AM

JJ4, Formation of Laterally Aligned InGaAs/GaAs Quantum-Dot Chains by Molecular-Beam and Atomic-Layer Epitaxy Techniques: *Sam Kyu Noh*¹; Sang Jun Lee¹; Jun Oh Kim¹; Young Guk Kim¹; Eun Kyu Kim²; Il Ki Han³; ¹Korea Research Institute of Standards and Science; ²Hanyang University; ³Korea Institute of Science and Technology

9:40 AM Student

JJ5, Characteristics of MOCVD Grown InGaAs QDs Embedded in GaAsP/InGaP Matrix: *Nam-Heon Kim*¹; Luke J. Mawst¹; Thomas F. Kuech¹; Troy J. Goodnough²; Manoj Kanskar²; ¹University of Wisconsin-Madison; ²Alfalight Inc.

10:00 AM Break

Session KK: Structure and Optical Properties of Complexes and Quantum Dots

Friday AM Room: Lobero
June 24, 2005 Location: University Center

Session Chairs: James L. Merz, University of Notre Dame; Ben Shanabrook, Naval Research Laboratory

10:20 AM Student

KK1, Elimination of ErAs Luminescence-Quenching Complexes from Er-Doped AlGaAs Native Oxides: *Mingjun Huang*¹; Douglas C. Hall¹; ¹University of Notre Dame

10:40 AM

KK2, Structural and Optical Studies of Integrated Semiconductor Nanocrystals Embedded - Single Crystal Semiconductor Systems: *Atul Konkar*¹; Siyuan Lu¹; Yi Zhang¹; Anupam Madhukar¹; Steven M. Hughes²; A. Paul Alivisatos²; ¹University of Southern California; ²University of California, Berkeley

11:00 AM

KK3, Optical and Structural Properties of InAs Quantum Dots Grown by Atomic Layer Molecular Beam Epitaxy and Conventional Molecular Beam Epitaxy: *Jin Dong Song*¹; Y. J. Park¹; W. J. Choi¹; I. K. Han¹; W. J. Cho¹; J. I. Lee¹; ¹Korea Institute of Science and Technology

11:20 AM Student

KK4, GaAs-Based Single Electron Y-Branch Switches for Hexagonal BDD Quantum Circuits: *Yuji Abe*¹; Miki Yumoto¹; Takahiro Tamura¹; Seiya Kasai¹; Hideki Hasegawa¹; ¹Hokkaido University

Session LL: Group III-Nitrides: Non-Polar Structures

Friday PM Room: Corwin East
June 24, 2005 Location: University Center

Session Chairs: Christian Wetzel, Future Chips Constellation; Russell Dupuis, Georgia Institute of Technology

1:30 PM

LL1, Radiative Lifetimes of Excitons in Non-Polar GaN/AlGaN Quantum Wells: *Sergey Rudin*¹; G. A. Garrett¹; M. Wraback¹; ¹U.S. Army Research Laboratory

1:50 PM

LL2, Density-Dependent Radiative Lifetime Measurements of GaN/AlGaN Multiple Quantum Wells on Laterally Overgrown *a*-Plane GaN: *Gregory A. Garrett*¹; H. Shen¹; S. Rudin¹; M. Wraback¹; B. Imer²; B. Haskell²;

J. S. Speck²; S. Keller²; S. Nakamura²; S. P. DenBaars²; ¹U.S. Army Research Laboratory; ²University of California, Santa Barbara

2:10 PM

LL3, Recombination Dynamics in Nonpolar (11-20) In_xGa_{1-x}N Multiple Quantum Wells Grown on GaN Templates Prepared by Lateral Epitaxial Overgrowth: *Takeyoshi Onuma*¹; Arpan Chakraborty²; Benjamin A. Haskell²; Stacia Keller²; Takayuki Sota³; Steven P. DenBaars²; James S. Speck²; Shuji Nakamura²; Umesh K. Mishra²; Shigefusa F. Chichibu¹; ¹University of Tsukuba and JST-ERATO; ²University of California, Santa Barbara and JST-ERATO; ³Waseda University

2:30 PM

LL4, Reconstructions and Adsorbates on Polar and Nonpolar GaN Surfaces: *David Segev*¹; Chris G. Van de Walle¹; ¹University of California, Santa Barbara

2:50 PM Student

LL5, Growth of Planar, Non-Polar (1 -1 0 0) m-Plane GaN Over m-Plane SiC by Metalorganic Chemical Vapor Deposition (MOCVD): *Bilge Imer*¹; Feng Wu¹; James Speck¹; Steven DenBaars¹; ¹University of California, Santa Barbara

3:10 PM Break

3:30 PM

LL6, Growth of p-Type m-Plane GaN on 6H m-Plane SiC via Plasma Assisted Molecular Beam Epitaxy: *Melvin McLaurin*¹; Tom Mates²; James S. Speck¹; ¹JST/ERATO University of California, Santa Barbara Group; ²University of California, Santa Barbara

3:50 PM Student

LL7, DC and Pulsed Performance of Nonpolar InGaN/GaN Light Emitting Diodes: *Arpan Chakraborty*¹; Benjamin A. Haskell¹; Mathew C. Schmidt¹; Stacia Keller¹; James S. Speck¹; Steven P. DenBaars¹; Shuji Nakamura¹; Umesh K. Mishra¹; ¹University of California, Santa Barbara

4:10 PM

LL8, Late News

Session MM: Nanocharacterization

Friday PM
June 24, 2005

Room: SB Harbor
Location: University Center

Session Chairs: Susanne Stemmer, University of California; Julia W.P. Hsu, Sandia National Laboratories

1:30 PM Student

MM1, Three-Dimensional Self-Organization of Self-Assembled InAs/InP(001) Quantum Dot Multilayers: Transition from Aligned to Anti-Aligned Structures: *Annie Levesque*¹; Remo A. Masut¹; Patrick Desjardins¹; ¹Ecole Polytechnique de Montreal

1:50 PM Student

MM2, Cross-Sectional Scanning Tunneling Microscopy and Spectroscopy of Confined States in InAs/GaAs Quantum Dots: *Vaishno D.*

*Dasika*¹; Jin Dong Song²; Rachel S. Goldman¹; ¹University of Michigan; ²Korea Institute of Science and Technology

2:10 PM

MM3, Anisotropic Lattice Deformation of InAs Self-Assembled Quantum Dots Strain Compensated with GaAsN Burying Layers: N. Matsumura¹; S. Muto²; Sasikala Ganapathy²; *Ikuo Suemune*²; ¹Institute for Physical and Chemical Research; ²Hokkaido University

2:30 PM

MM4, Optical and Near-Field Study of InGaN/GaN and InGaN/InGaN QDs Grown in a Wide-Pressure-Range MOCVD Reactor: D. S. Sizov¹; V. S. Sizov¹; V. V. Lundin¹; E. E. Zavarin¹; A. F. Tsatsul'nikov¹; A. S. Vlasov¹; N. N. Ledentsov¹; A. M. Mintairov²; K. Sun²; *James L. Merz*²; ¹A.F. Ioffe Physico-Technical Institute; ²University of Notre Dame

2:50 PM

MM5, Late News

Session NN: Epitaxy for Devices

Friday PM
June 24, 2005

Room: State Street
Location: University Center

Session Chairs: Charles Lutz, Kopin Corporation; Archie L. Holmes, University of Texas

1:30 PM Student

NN1, Enhanced Hall Mobility and Very Low Dislocation Density in Si_{1-x}Ge_x Epitaxial Layers Grown by MBE on a Patterned Template: *Joo-Young Lee*¹; Hyung-Jun Kim¹; Miqiang Bao¹; Kang L. Wang¹; ¹University of California, Los Angeles

1:50 PM Student

NN2, Carrier Confinement in Almost Pure Ge Channels Grown on Si Substrates by Rapidly Graded Si_{1-x}Ge_x Growth: *Sachin Joshi*¹; Sagnik Dey¹; Kevin Jones²; Michelle Chaumont¹; Alan Champion¹; David Q. Kelly¹; Joseph Donnelly¹; Sanjay K. Banerjee¹; ¹University of Texas at Austin; ²University of Florida at Gainesville

2:10 PM Student

NN3, Epitaxial Growth of Ca_xMg_{1-x}F₂ Alloy for Fluoride Ultra-Thin Heterostructures on Si Substrates: *Natsuko Matsudo*¹; Motoki Maeda¹; So Watanabe¹; Kazuo Tsutsui¹; ¹Tokyo Institute of Technology

2:30 PM

NN4, Oxide Desorption from GaP Substrates via Ga Pulsing Prior to MBE: *Jerry M. Woodall*¹; A. J. SpringThorpe²; A. Yulius³; ¹Purdue University; ²National Research Council of Canada; ³Yale University

2:50 PM Student

NN5, ErAs-InAlGaAs: An Epitaxial Schottky Diode Materials System: *Jeremy David Zimmerman*¹; Adam C. Young¹; Dmitri O. Klenov¹; Susanne Stemmer¹; Elliott R. Brown¹; Arthur C. Gossard¹; ¹University of California, Santa Barbara

3:10 PM Break

3:30 PM Student

NN6, Quantum Well Intermixing and MOCVD Regrowth for the Monolithic Integration of UTC Type Detectors with Quantum Well Based Components: *James W. Raring*¹; Erik J. Skogen¹; Jonathon S. Barton¹; Steven P. DenBaars¹; Larry A. Coldren¹; ¹University of California, Santa Barbara

3:50 PM

NN7, Defect Reduction at the AlGaAsSb/InP Interface for Optimized Long-Wavelength Vertical Cavity Lasers: *David Buell*¹; Danny Feezell¹; Larry Coldren¹; ¹University of California, Santa Barbara

4:10 PM

NN8, Intracavity Grating- and Current-Confined All-Epitaxial Vertical-Cavity Surface-Emitting Laser Based on Selective Interface Fermi-Level Pinning: *Deepa Gazula*¹; Jaemin Ahn¹; Dingyuan Lu¹; Hua Huang¹; Dennis G. Deppe¹; ¹University of Texas at Austin

4:30 PM Student

NN9, Reactive Ion Etch Damage and Plasma-Enhanced Chemical Vapor Deposition Repair of Vertical-Cavity Surface-Emitting Lasers: *Paul O. Leisher*¹; James J. Raftery, Jr.¹; Anas M. Kasten¹; Kent D. Choquette¹; ¹University of Illinois

4:50 PM

NN10, Green-Orange InGaP LEDs Grown on In_xGa_{1-x}P/GaP Graded Buffer Substrate: *Lorant Peternai*¹; Jaroslav Kovac¹; Jozef Novak²; Stanislav Hasenöhrl²; Alexander Satka³; Andrej Vincze³; ¹Slovak University of Technology Bratislava; ²Slovak Academy of Science; ³International Laser Center